

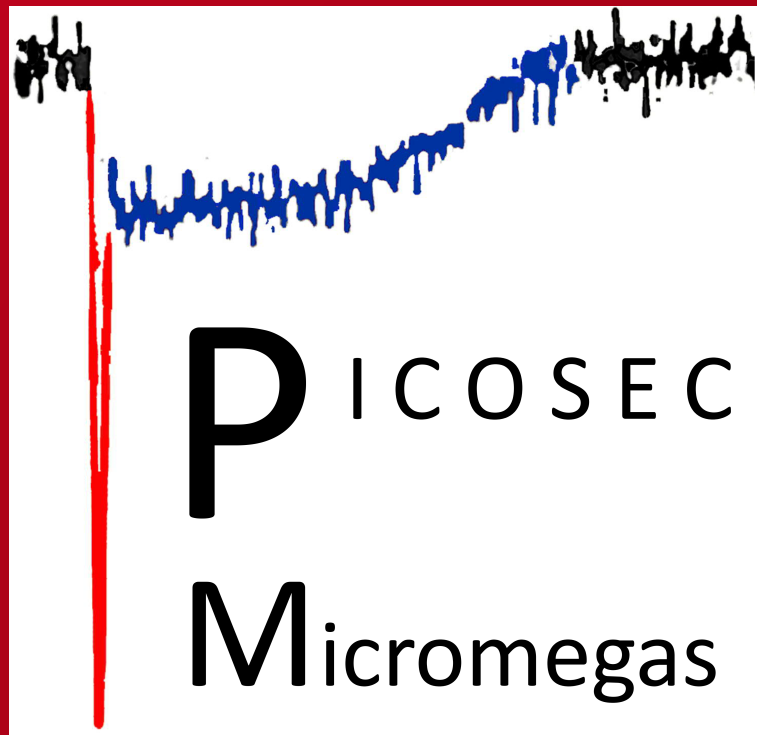
DE LA RECHERCHE À L'INDUSTRIE



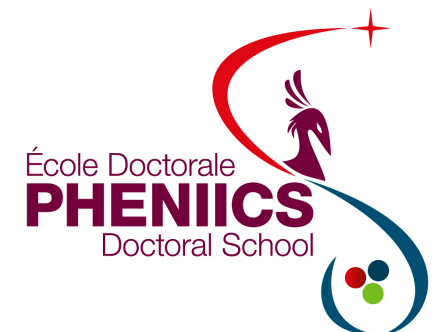
In-depth studies of time performance of the PICOSEC-Micromegas detector concept

@

IPRD19 Siena

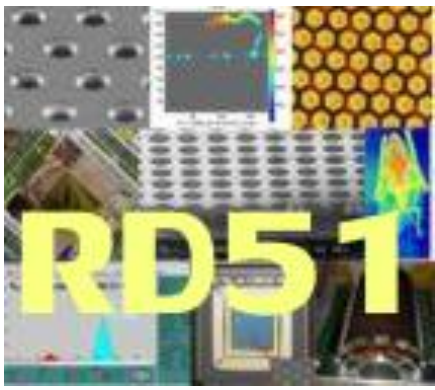


Lukas SOHL
15.10.2019



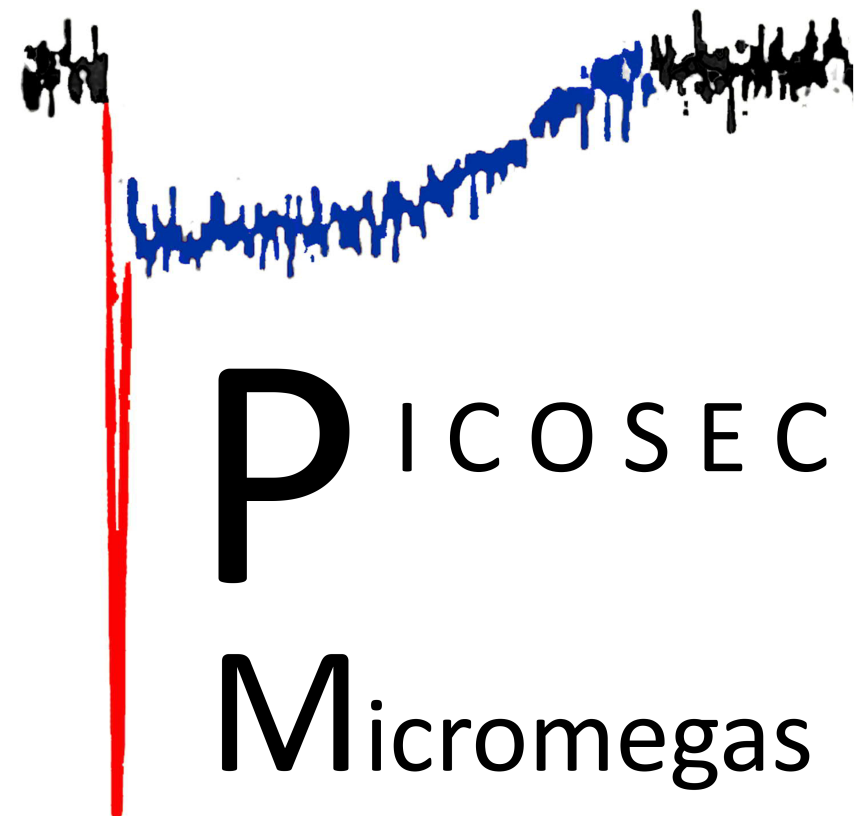
What to expect in the next 15 minutes:

- **What is a PICOSEC-Micromegas**
 - ▶ **and why it does have such a good time resolution**
- **Laser measurement set-up**
- **Effects of the drift gap on the time resolution**
- **Pre-studies of gas mixtures**
- **Outlook on further developments**



RD51 R&D Project: PICOSEC-Micromegas

- **CEA Saclay (France):** D. Desforge, I. Giomataris, T. Gustavsson, C. Guyot, F.J. Iguaz¹, M. Kebbiri, P. Legou, T. Papaevangelou, M. Pomorski, P. Schwemling, E. Scorsone, L. Sohl.
- **CERN (Switzerland):** J. Bortfeldt, F. Brunbauer, C. David, M. Lupberger, H. Müller, E. Oliveri, F. Resnati, L. Ropelewski, T. Schneider, P. Thuiner, M. van Stenis, R. Veenhof², S. White³.
- **USTC (China):** J. Liu, B. Qi, X. Wang, Z. Zhang, Y. Zhou.
- **AUTH (Greece):** I. Manthos, V. Niaouris, K. Paraschou, Ch. Petridou D. Sampsonidis, S.E. Tzamarias.
- **NCSR (Greece):** G. Fanourakis.
- **NTUA (Greece):** Y. Tsipolitis.
- **LIP (Portugal):** M. Gallinaro.
- **HIP (Finland):** F. García.
- **IGFAE (Spain):** D. González-Díaz.

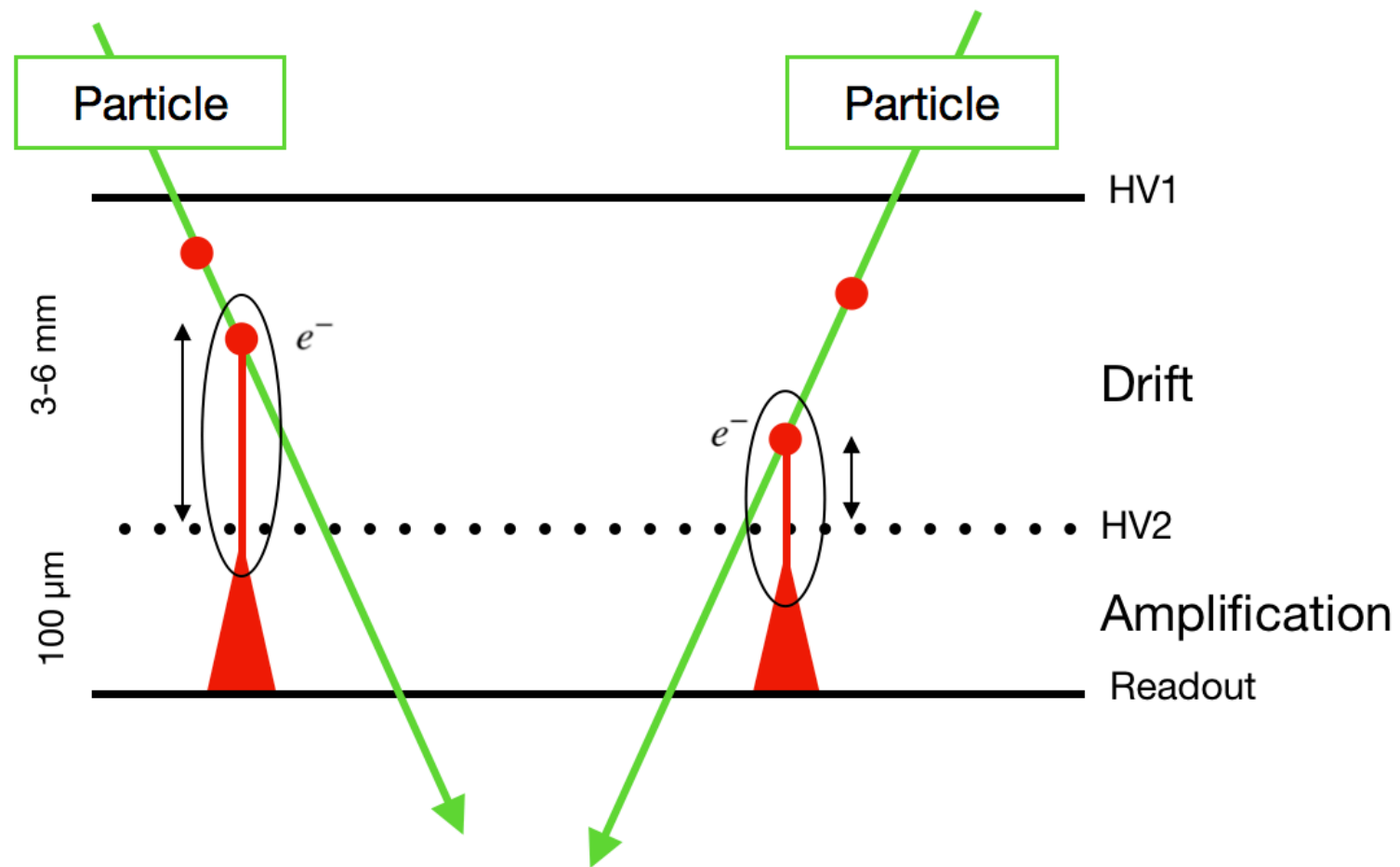


¹ Now at Synchrotron Soleil, 91192 Gif-sur-Yvette, France

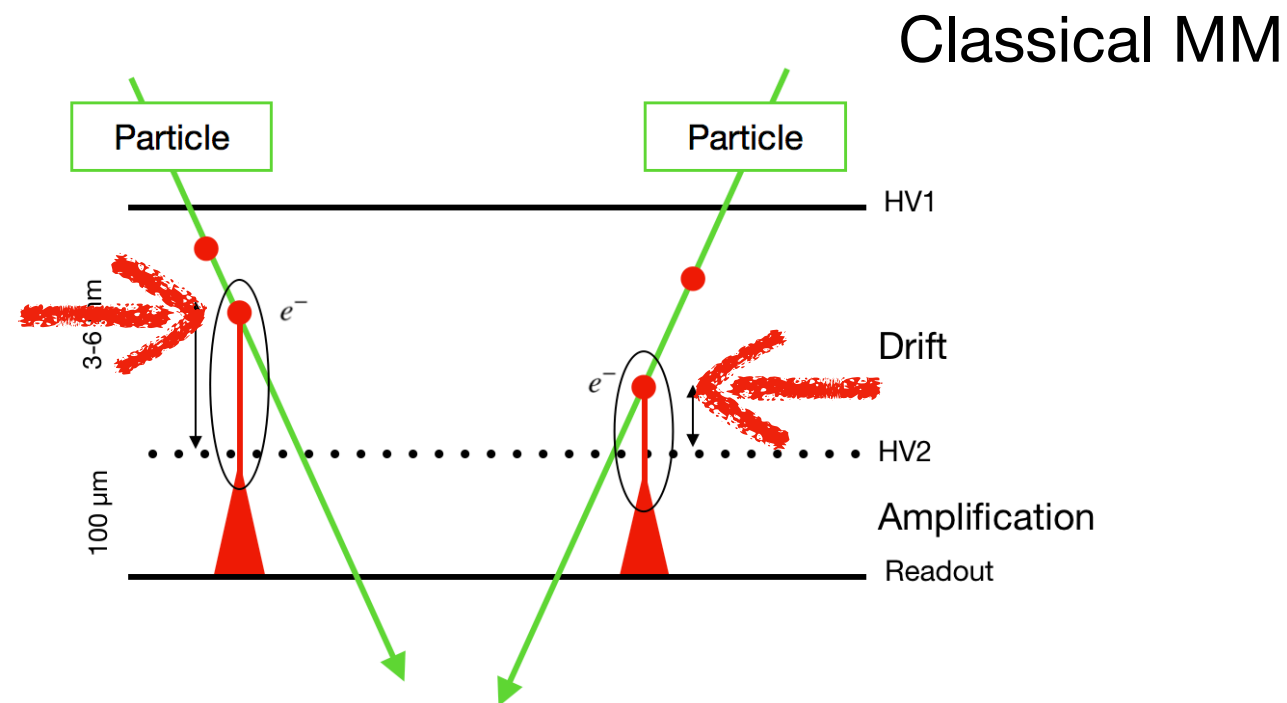
² Also MEPhI & Uludag University.

³ Also University of Virginia.

PICOSEC Micromegas

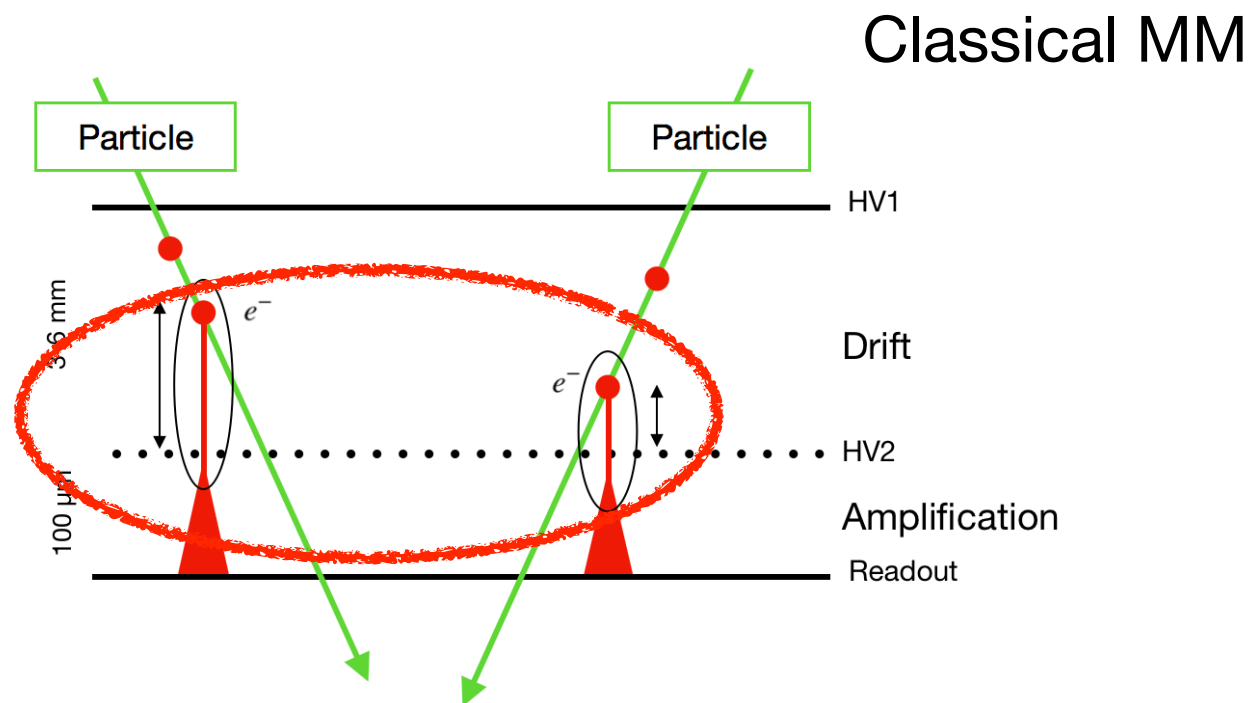


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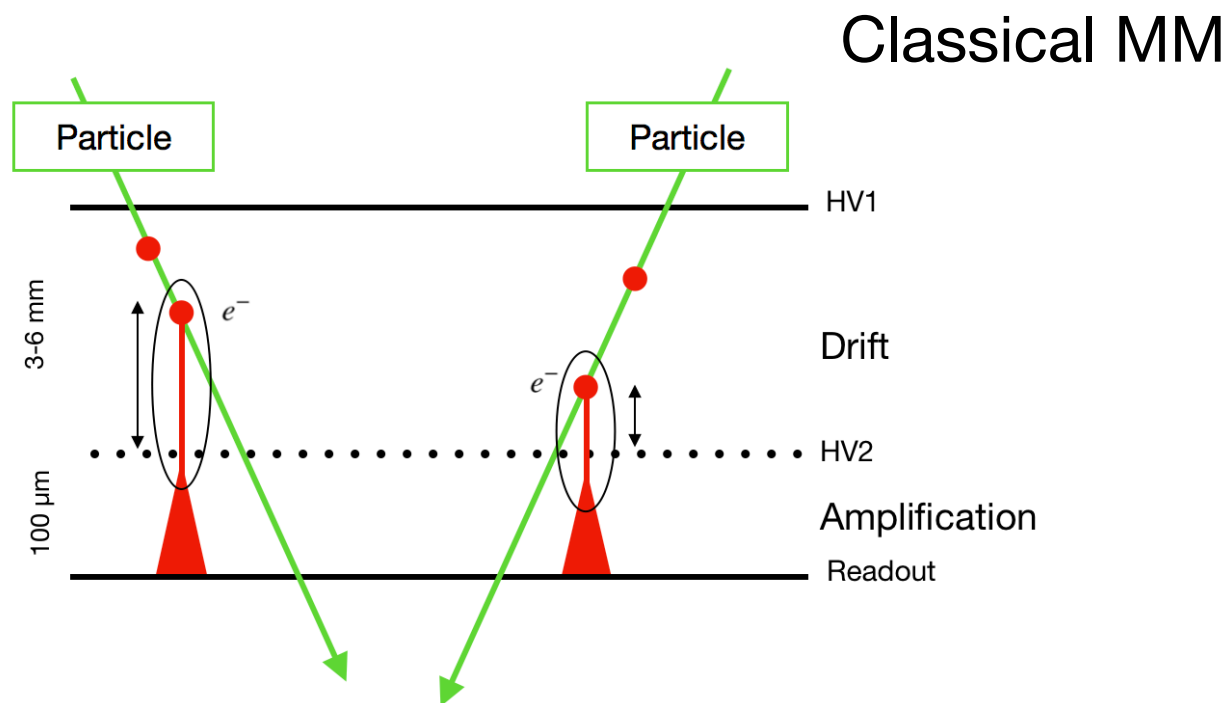
- Different **position** of ionisation clusters at direct **gas ionisation**

PICOSEC Micromegas



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- Inevitable signal arrival time **jitter** due to **drift velocity** and average **ionisation length**

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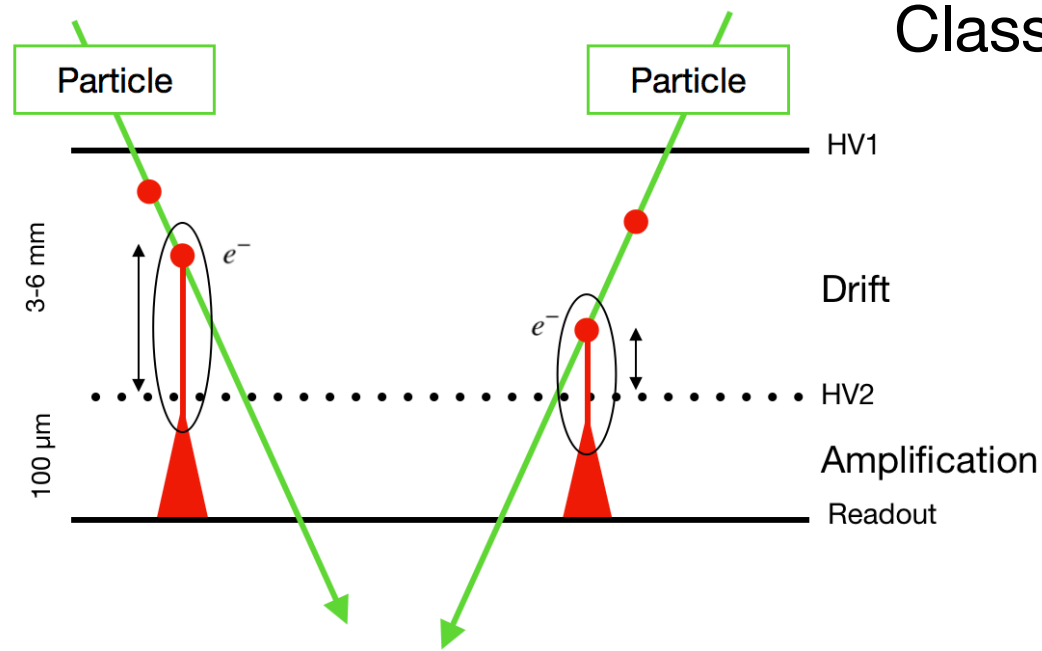


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$$\sigma_t = \frac{\sigma_I}{v_d} = \frac{355 \mu\text{m}}{84 \frac{\mu\text{m}}{\text{ns}}} \approx 4 \text{ ns}$$

Estimated time jitter for COMPASS Micromegas

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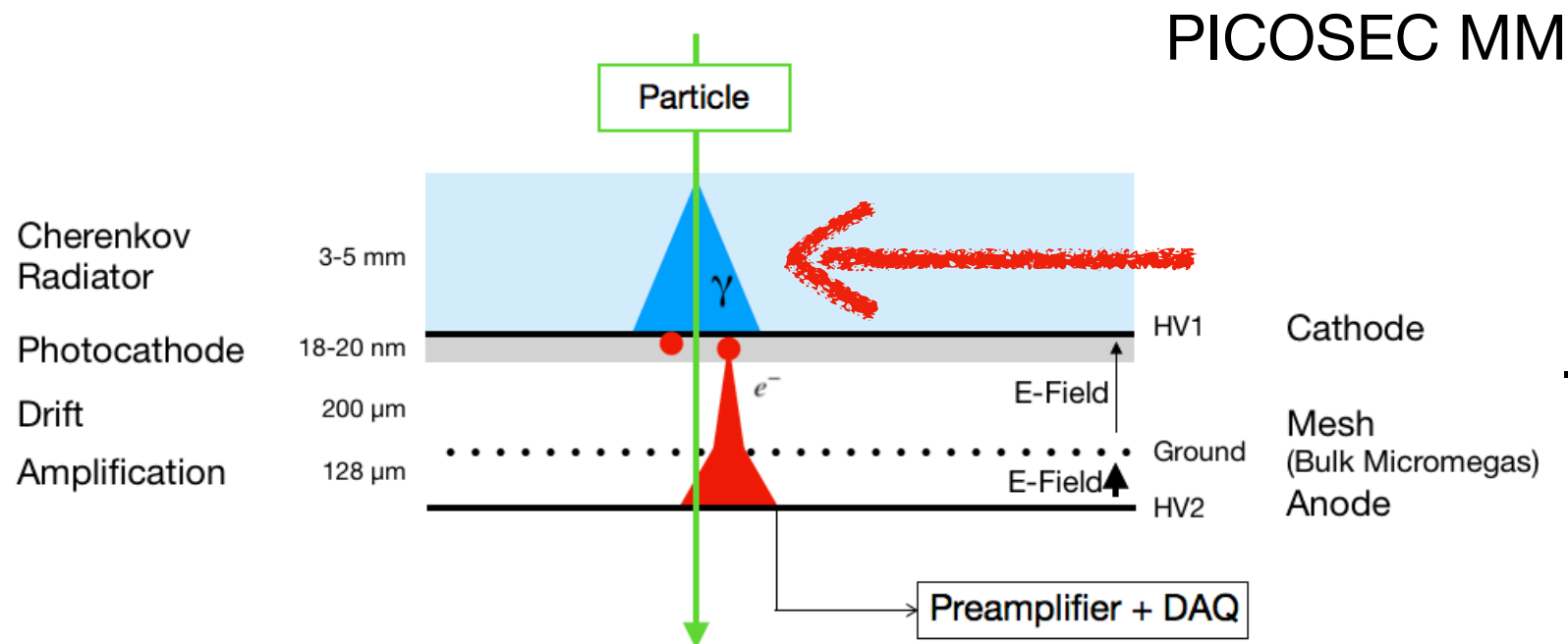


Classical MM

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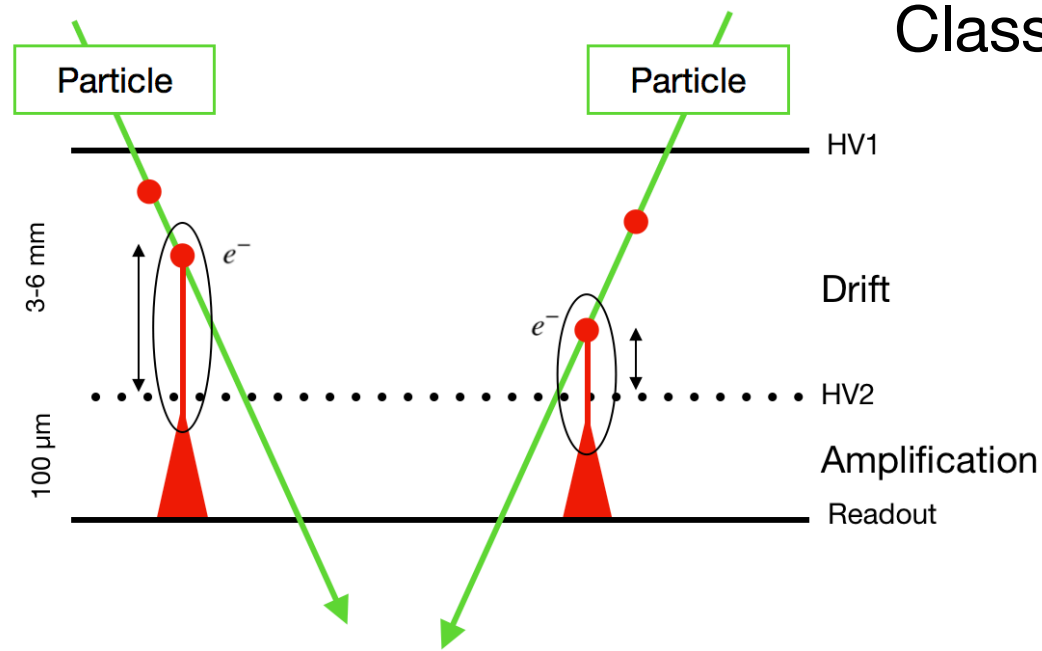
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PICOSEC MM

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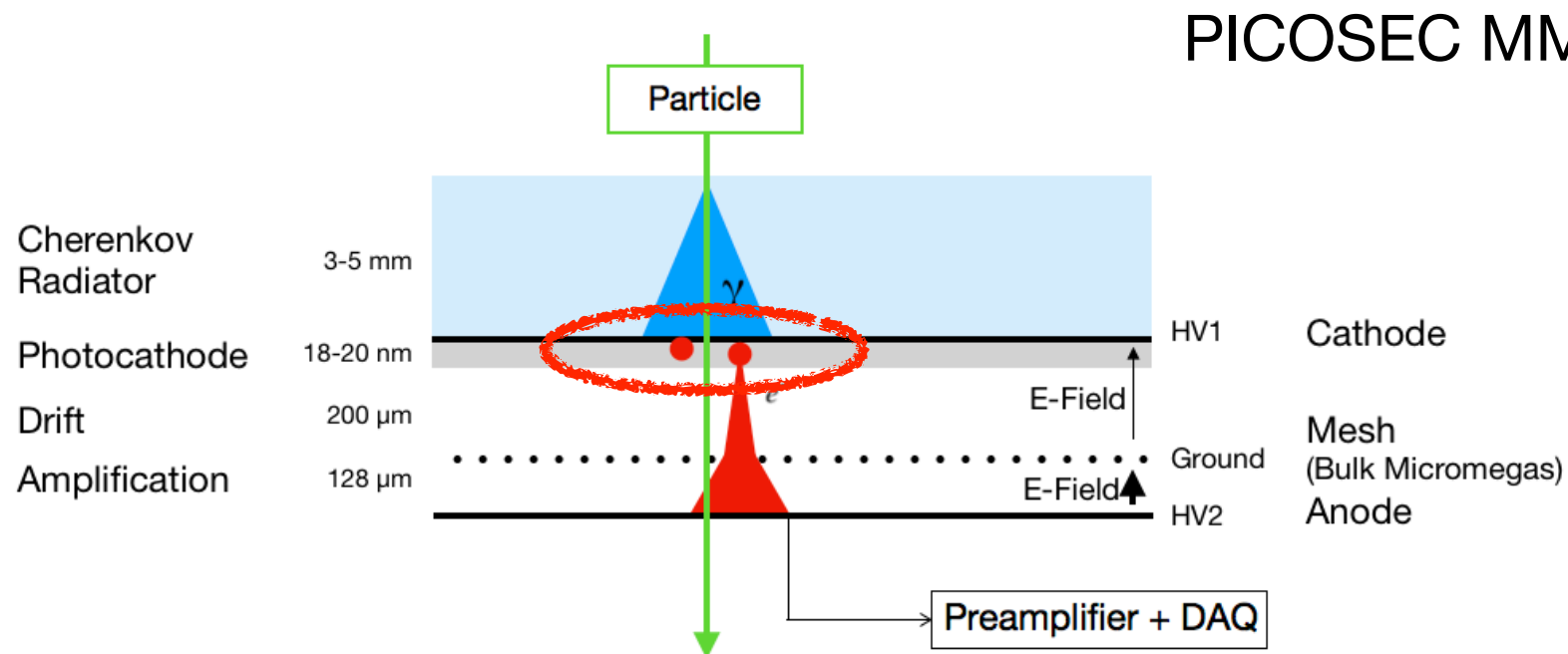


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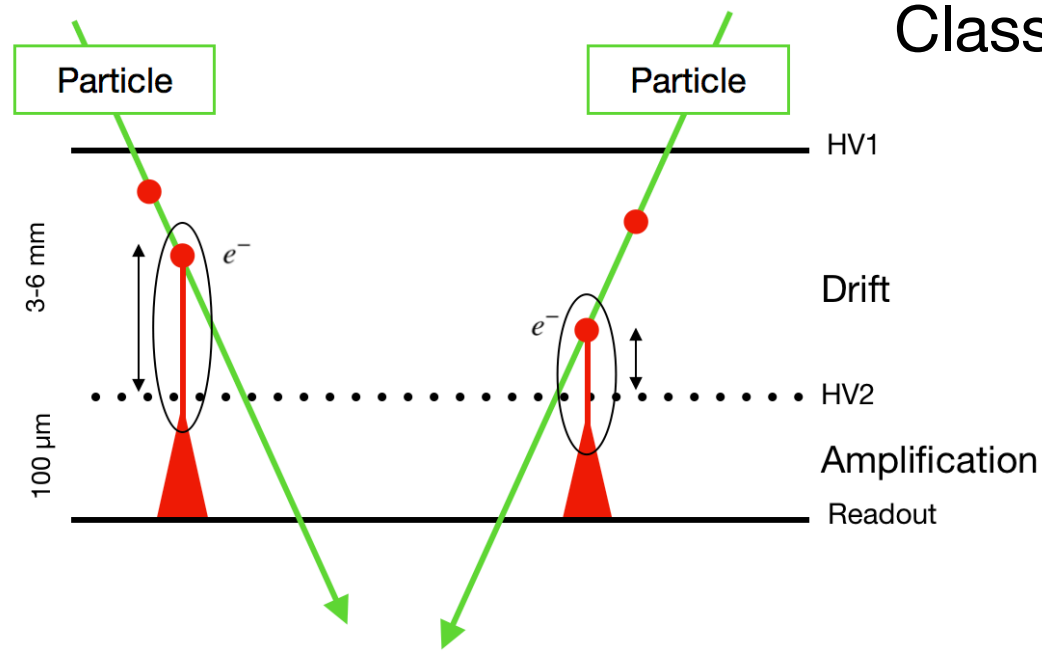
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PICOSEC MM

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- Electrons are emitted by the radiation in a photocathode
- All primary ionised electrons are **localised on the photocathode**

PICOSEC Micromegas

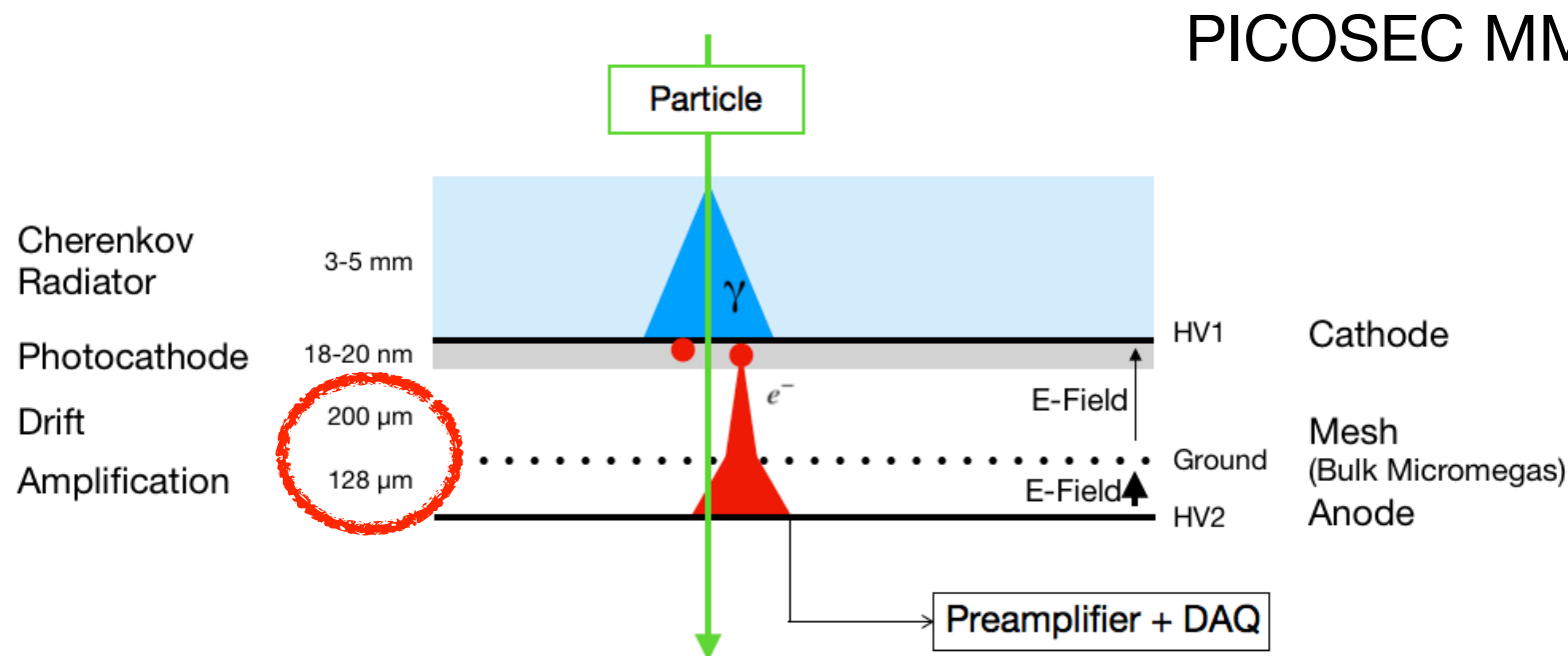


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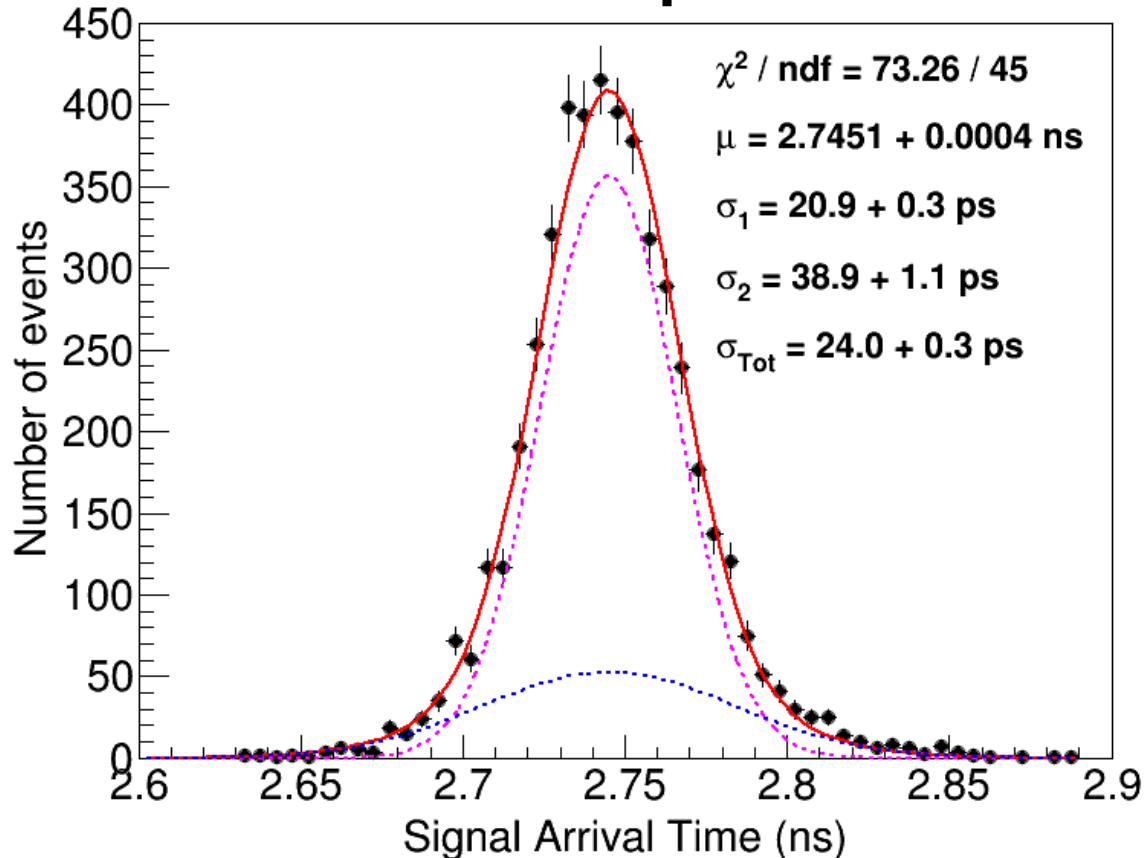


PICOSEC MM

- Particle produce **Cherenkov radiation**
- Electrons are emitted by the radiation in a photocathode
- All primary ionised electrons are **localised on the photocathode**
- Due to high electric field, time **jitter** before first amplification **minimised**

Previous Development

Time Resolution ~24 ps in muon beam

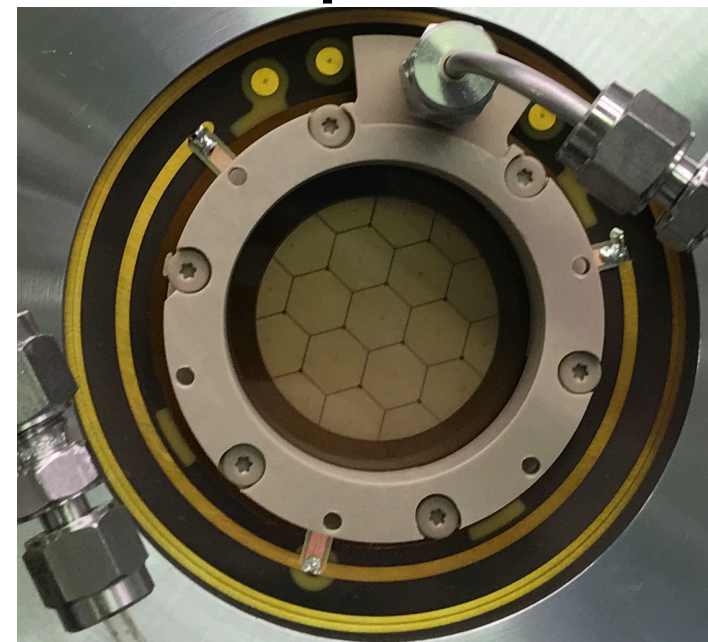


Different photocathode materials tested

Thickness of DLC film (nm)	Npe/per muon	Detection efficiency for muons
1	Bad	Bad
2.5	3.7	97%
5	3.4	94%
7.5	2.2	70%
10	1.7	68%
5 nm Cr + 18 nm CsI	7.4	100%

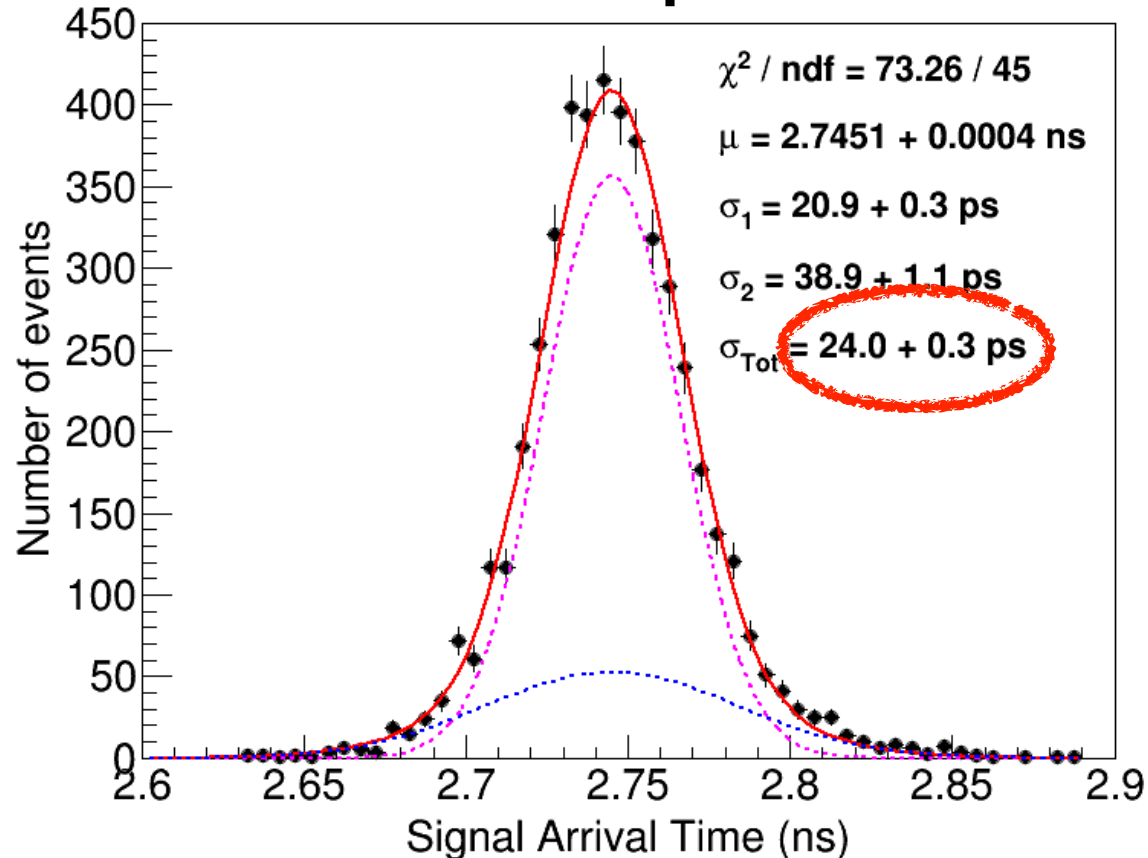
- Fast Timing for High-Rate Environments with Micromegas, EPJ Web of Conferences **174**, 02002 (2018), doi: 10.1051/epjconf/201817402002
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- Precise charged particle timing with the PICOSEC detector, AIP Conference Proceedings **2075**, 080009 (2019); doi: 10.1063/1.5091210
- PICOSEC-Micromegas: Robustness measurements and study of different photocathode materials, J. Phys.: Conf. Ser. **1312** (2019) 012012 ; doi: 10.1088/1742-6596/1312/1/012012

First Multipad Detector



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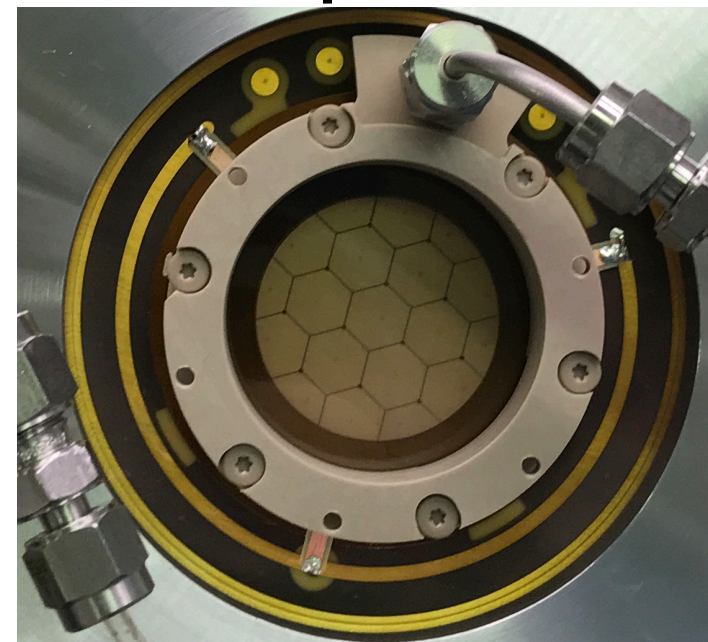


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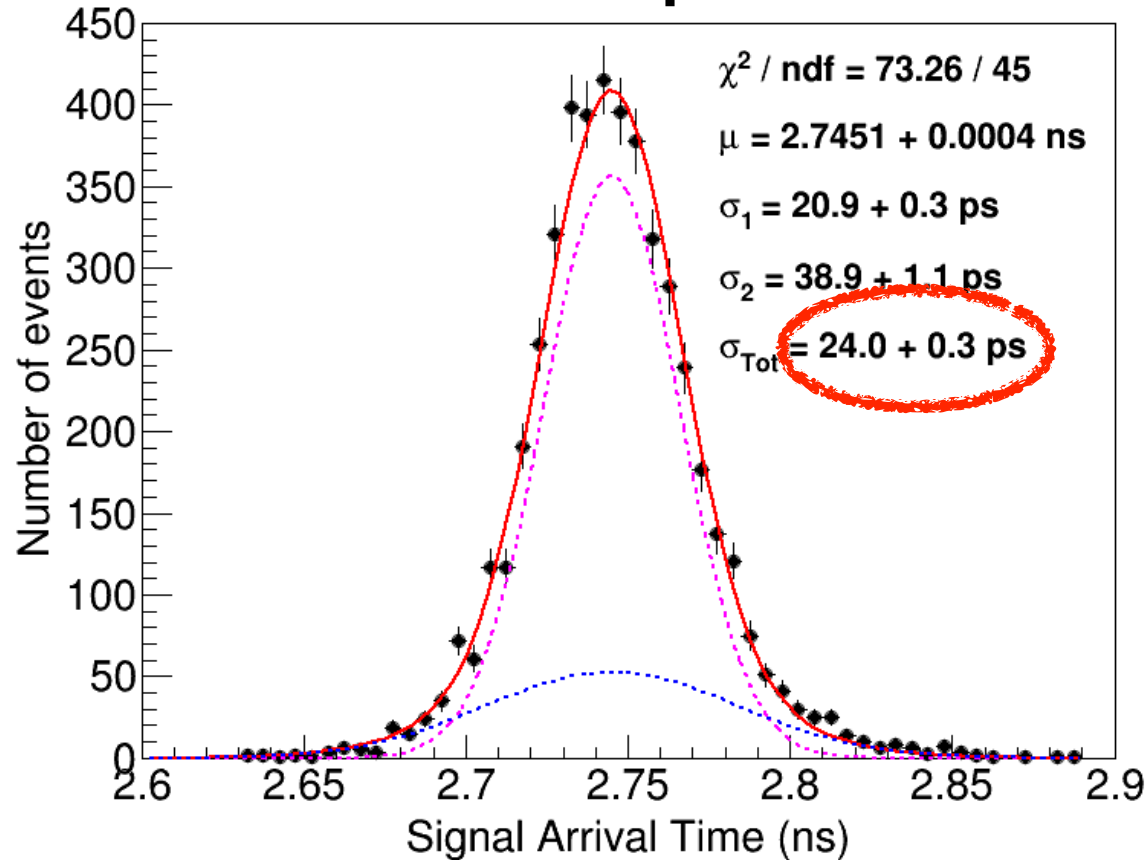
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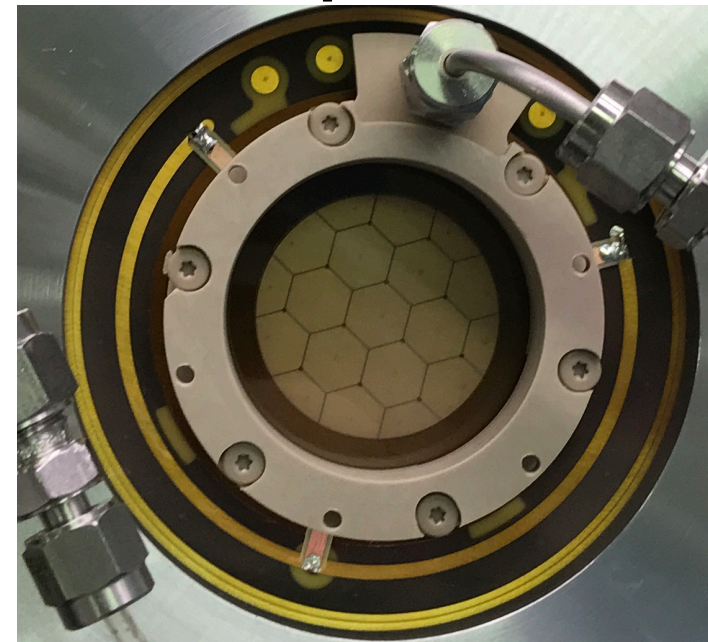


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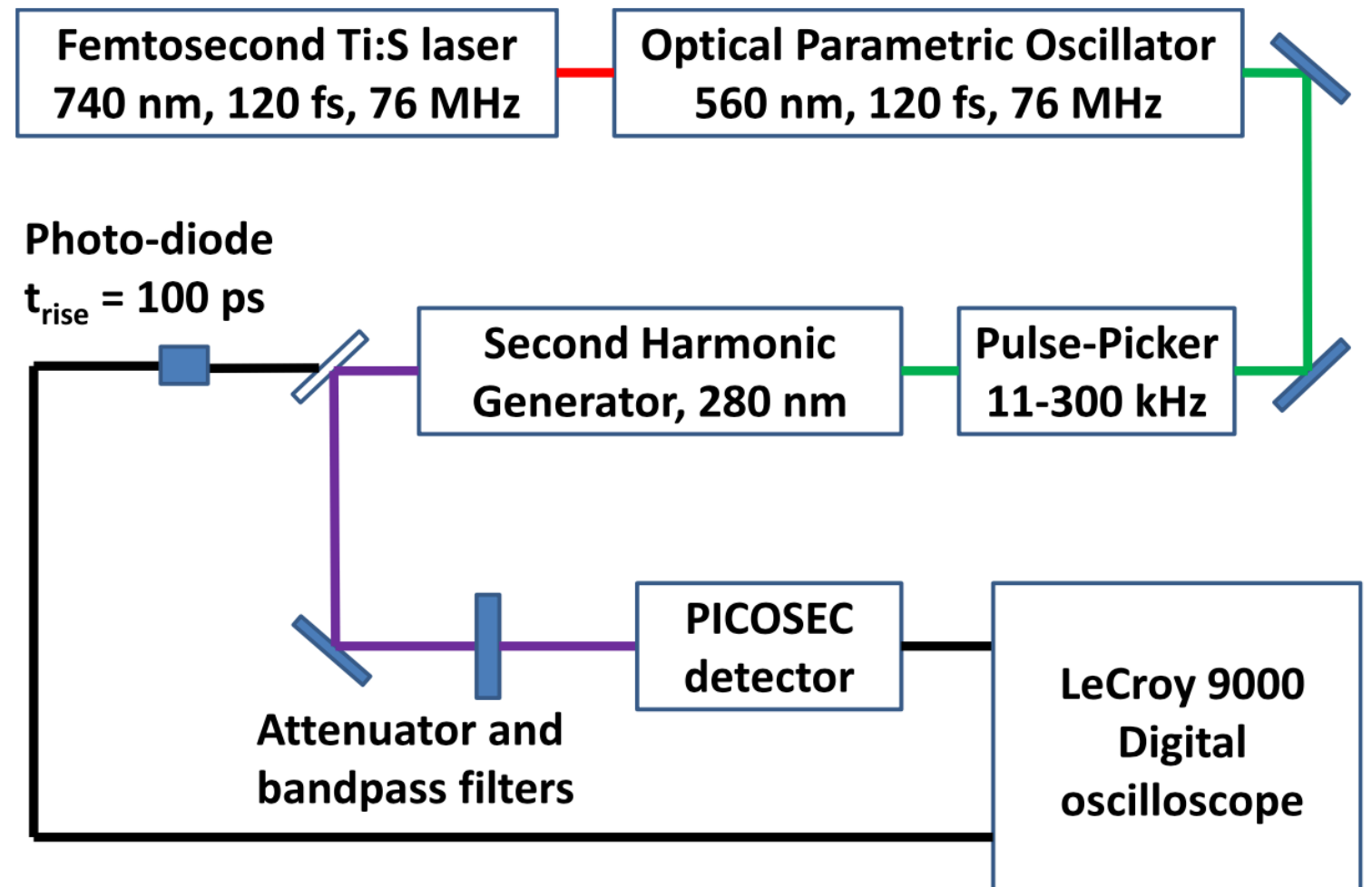
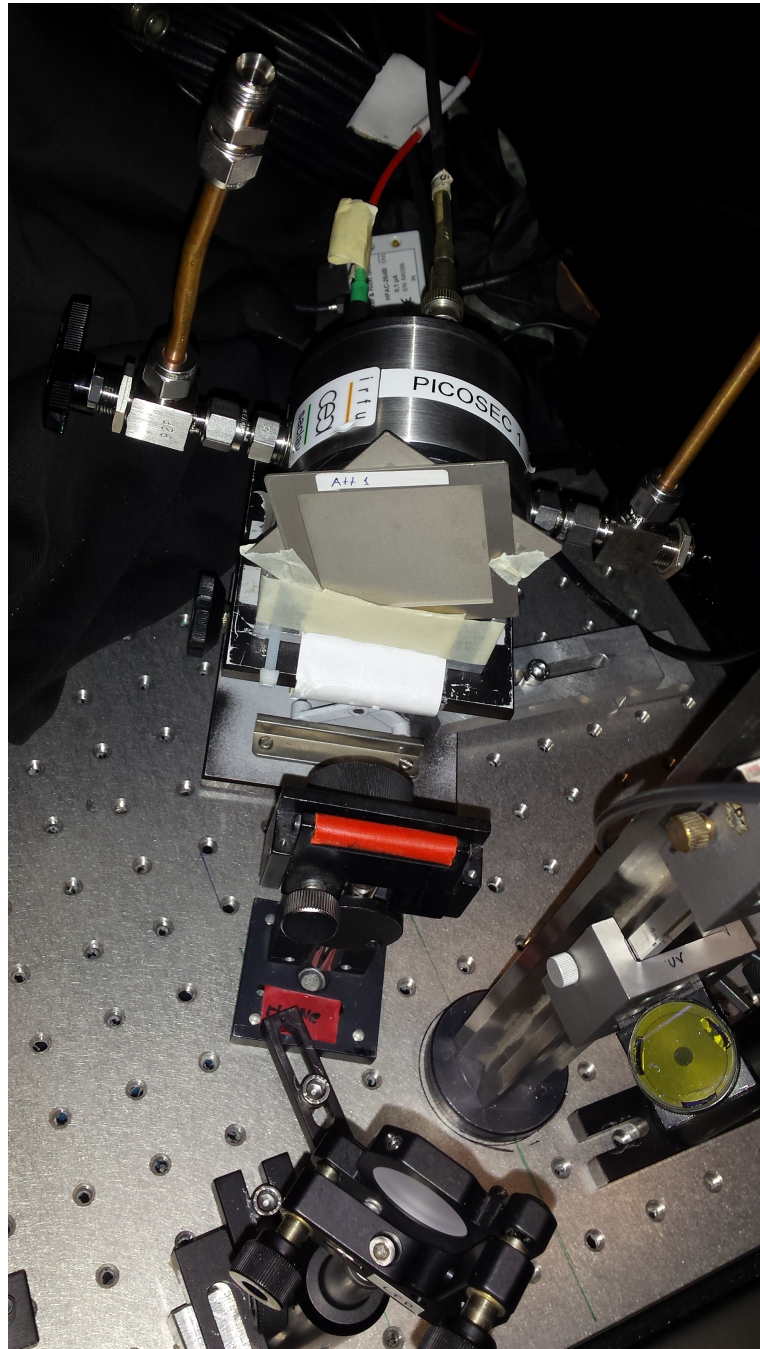
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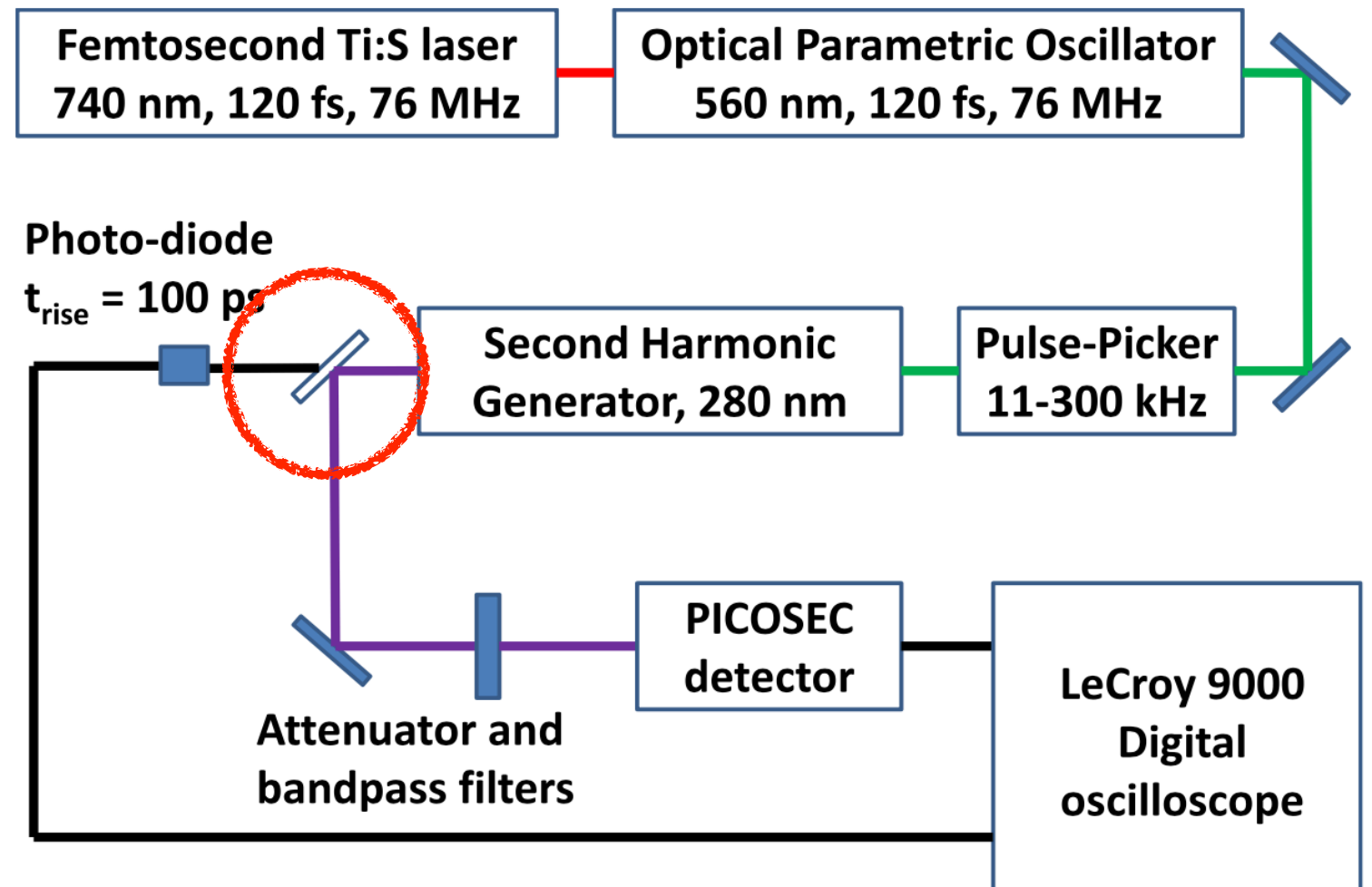
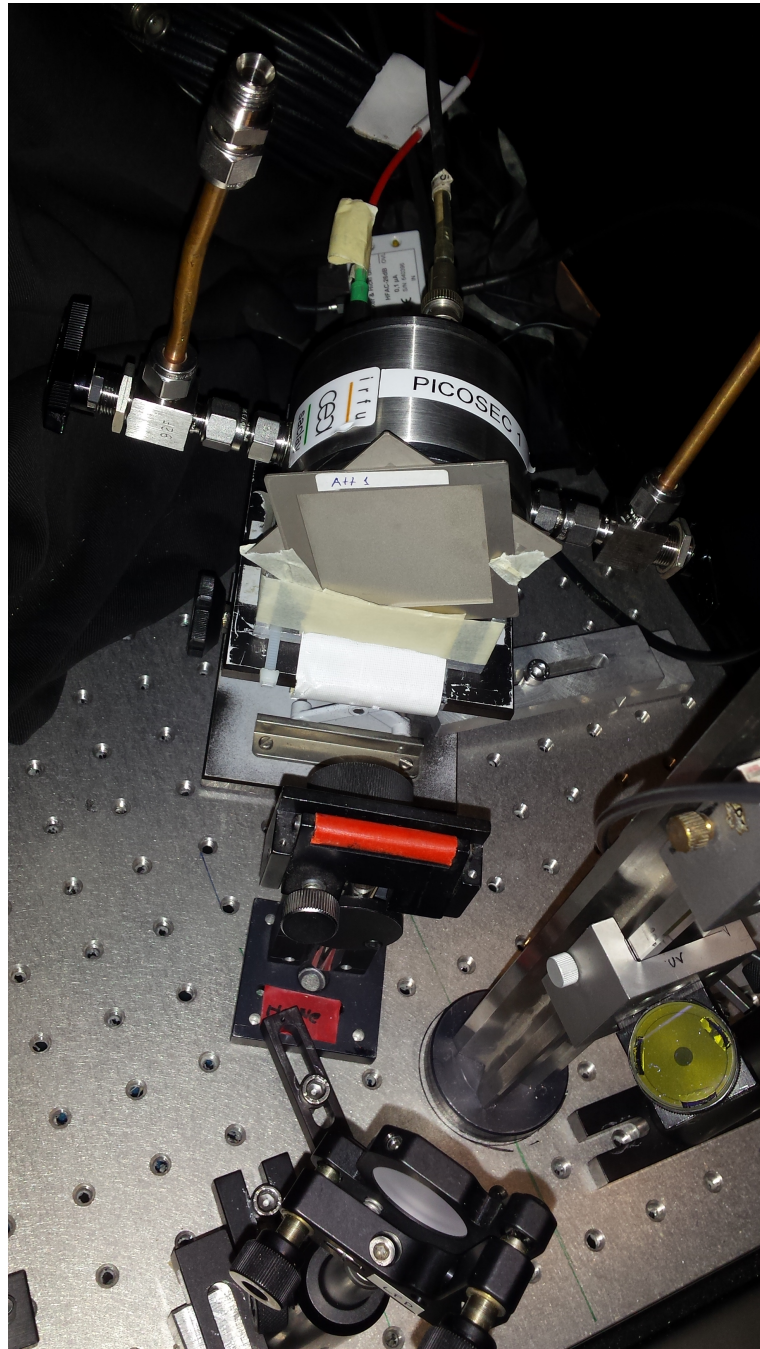


Clean measurements with a Laser



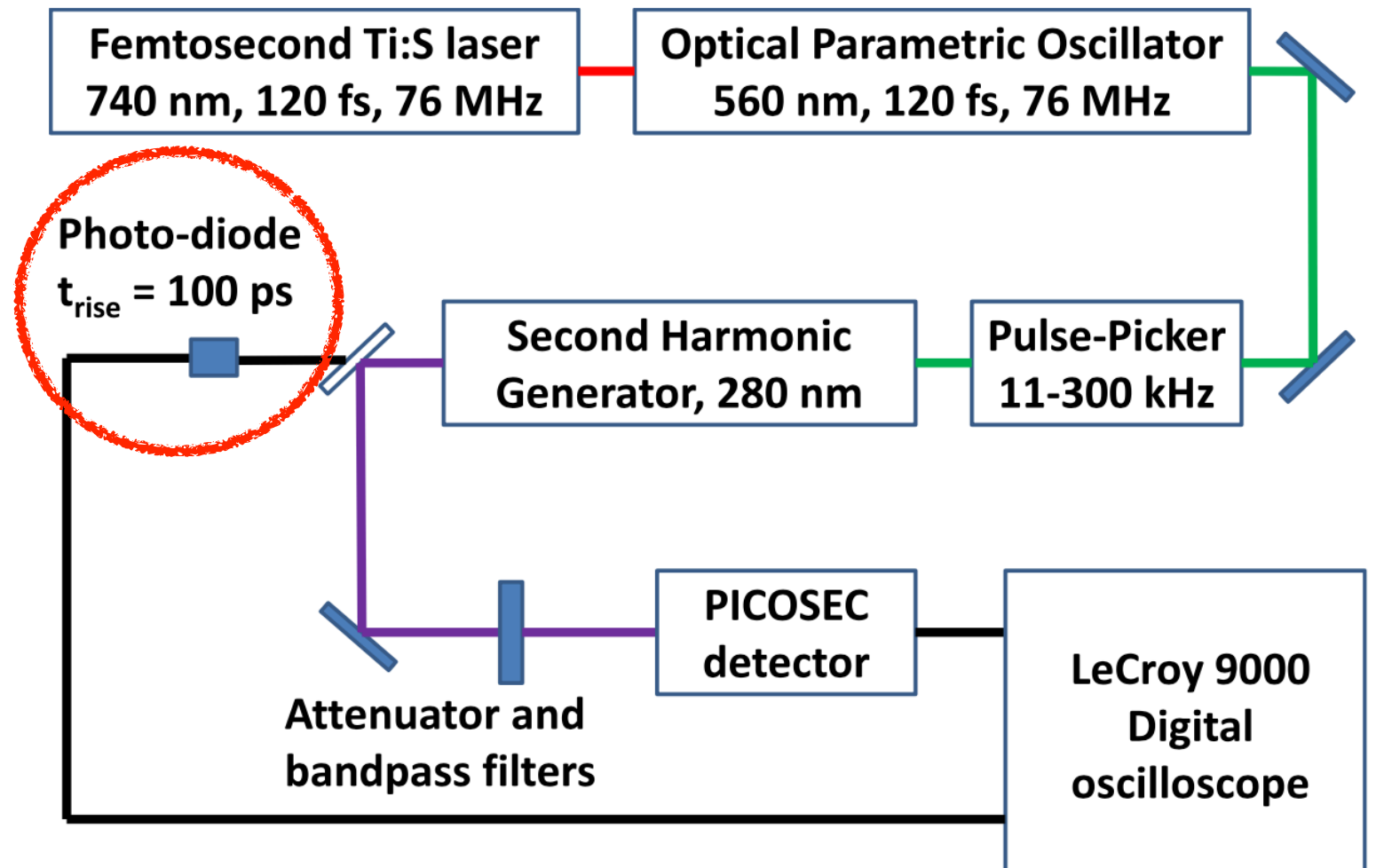
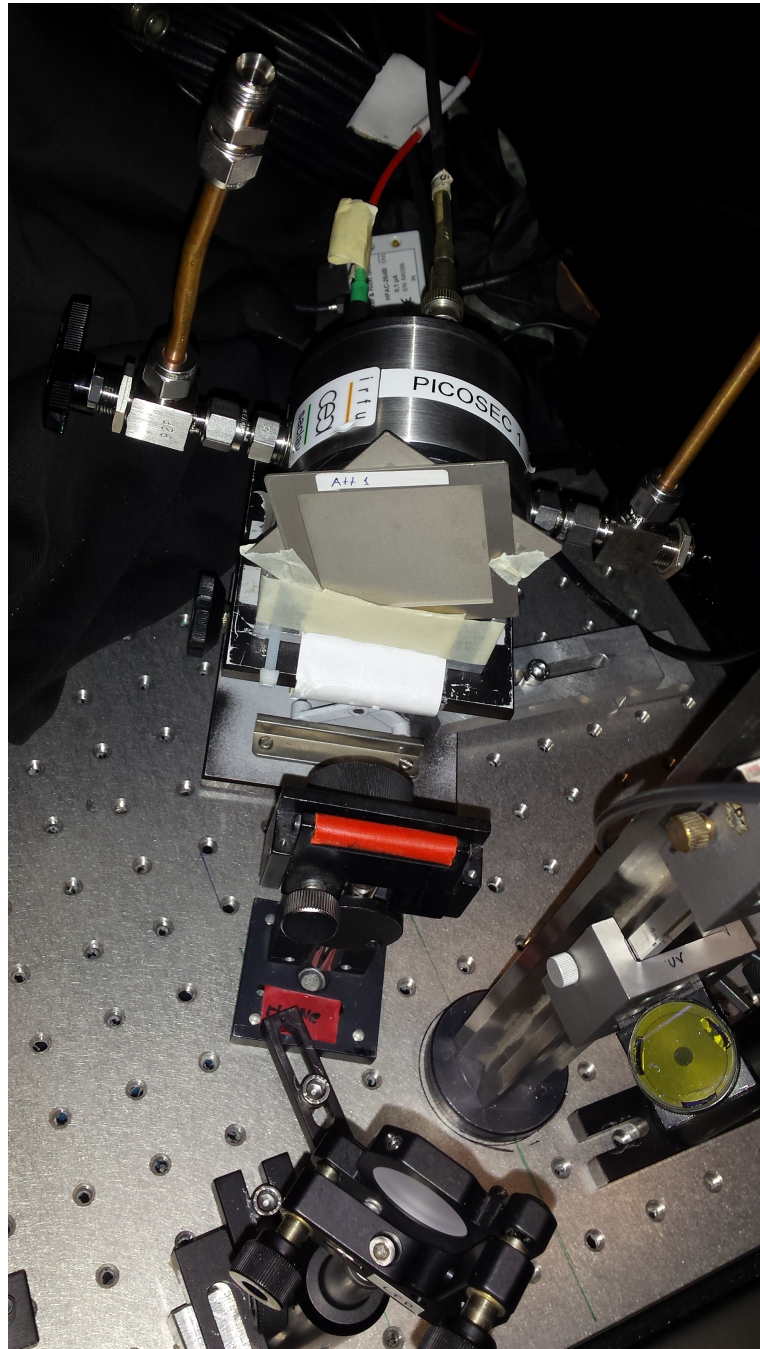
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- 267 - 288 nm Wavelengths
- Repetition rate up to 500 kHz
- Laser intensity attenuated to study **single photoelectron emission**

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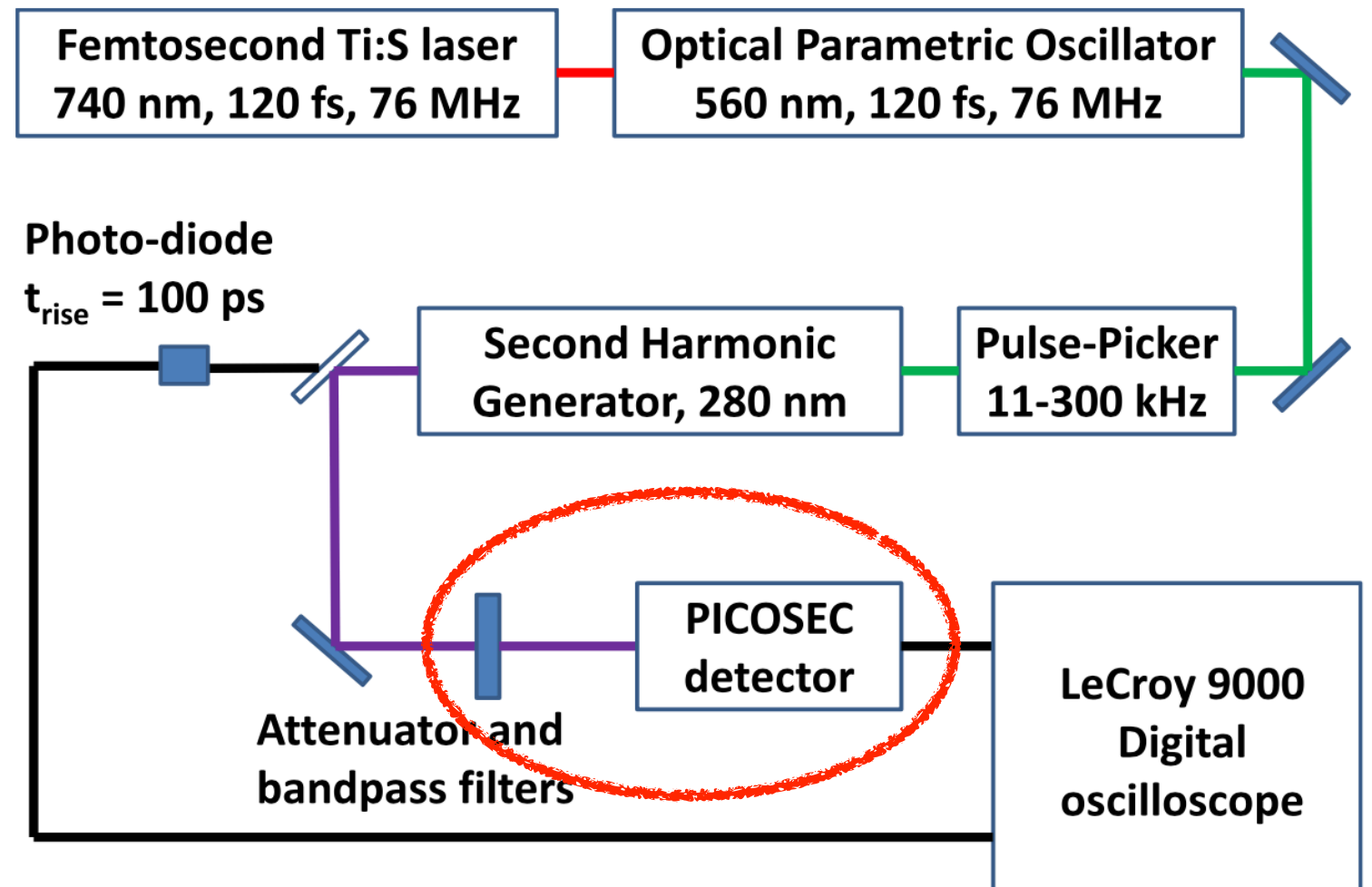
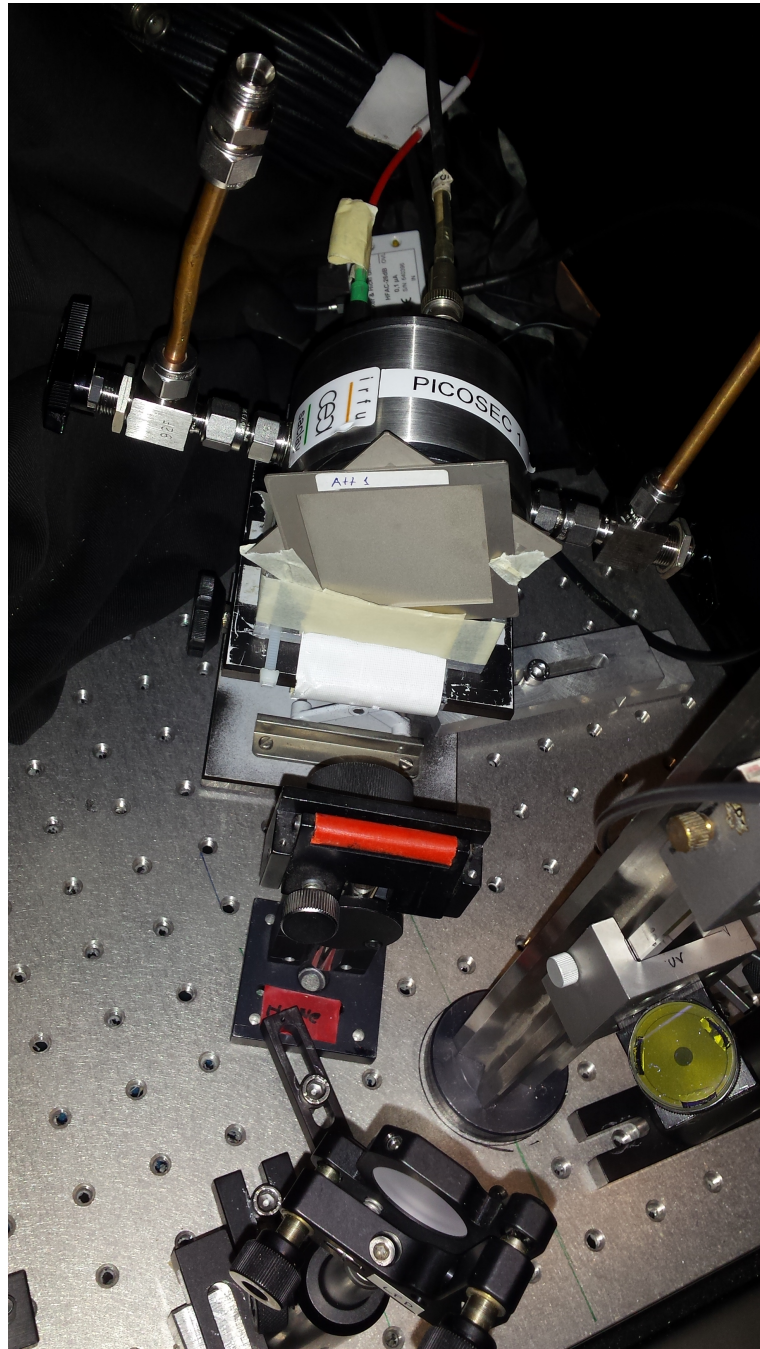
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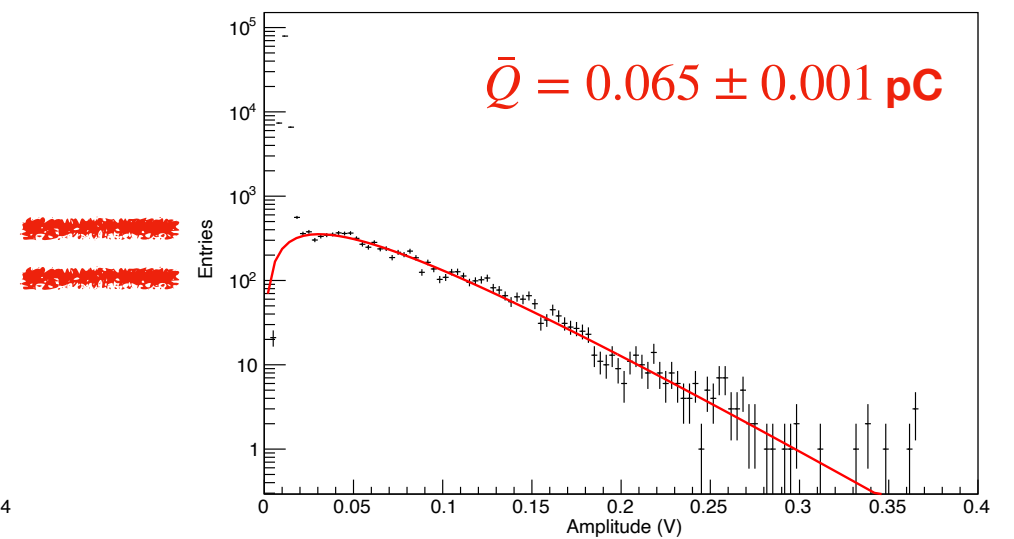
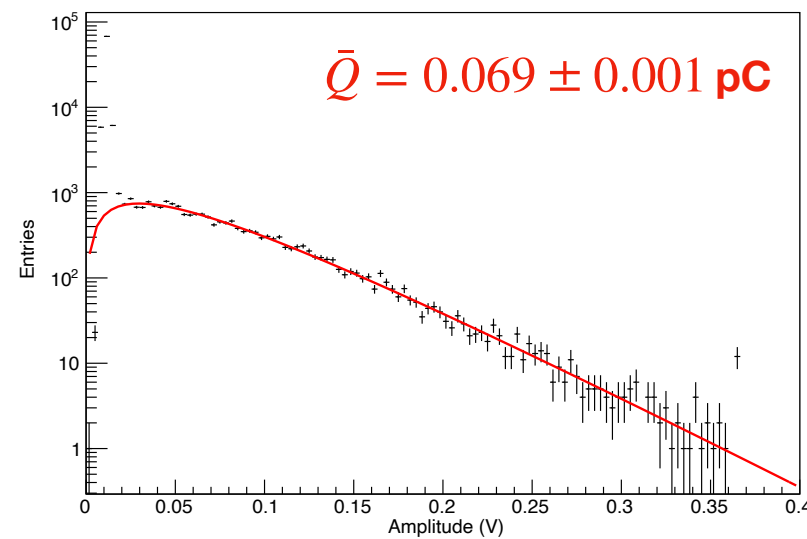
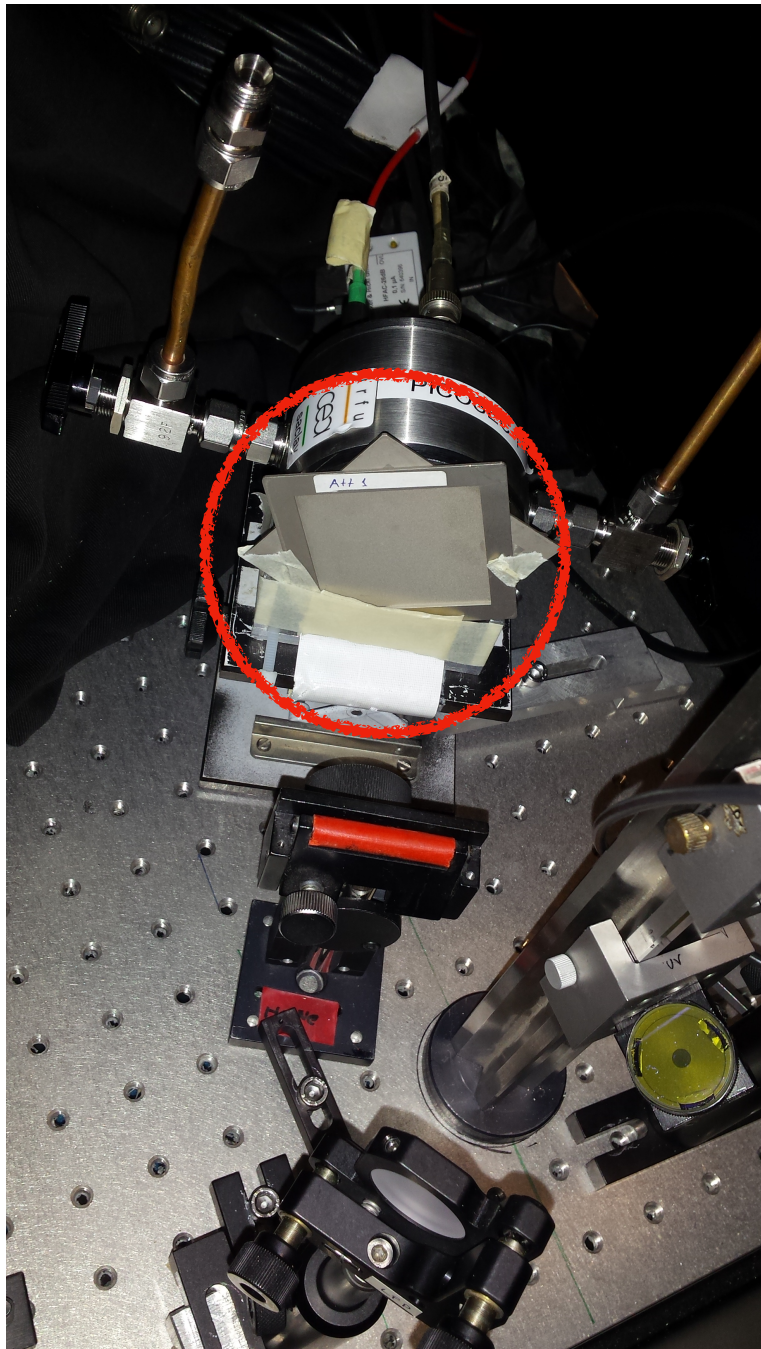
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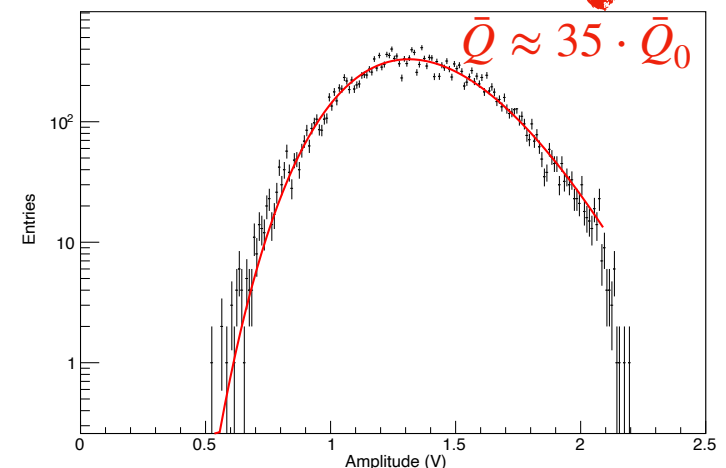
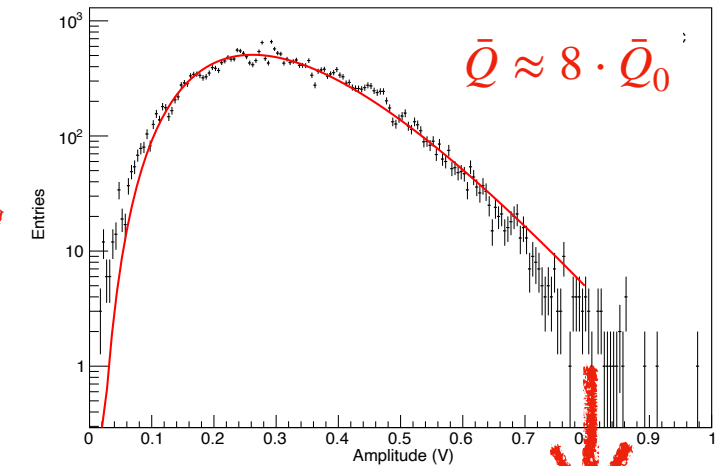
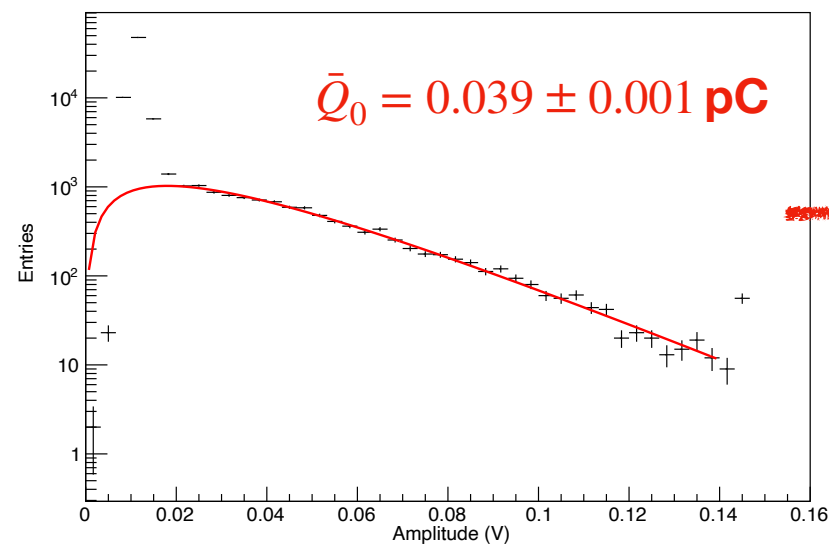
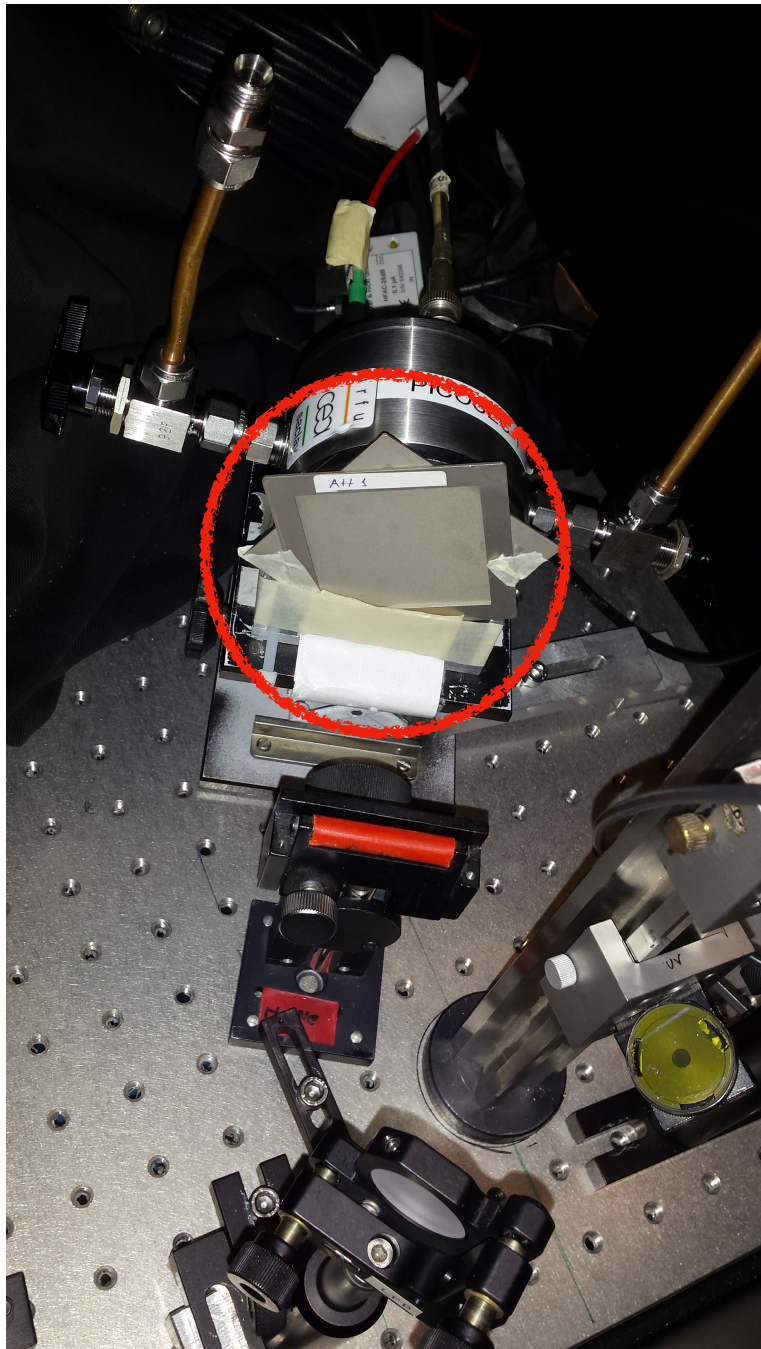
Light attenuation for 1 p.e. measurements with attenuators

- Mean signal size is determined by a **Polya fit**
- 1 p.e. condition: additional **attenuators** are **not changing** the mean signal size



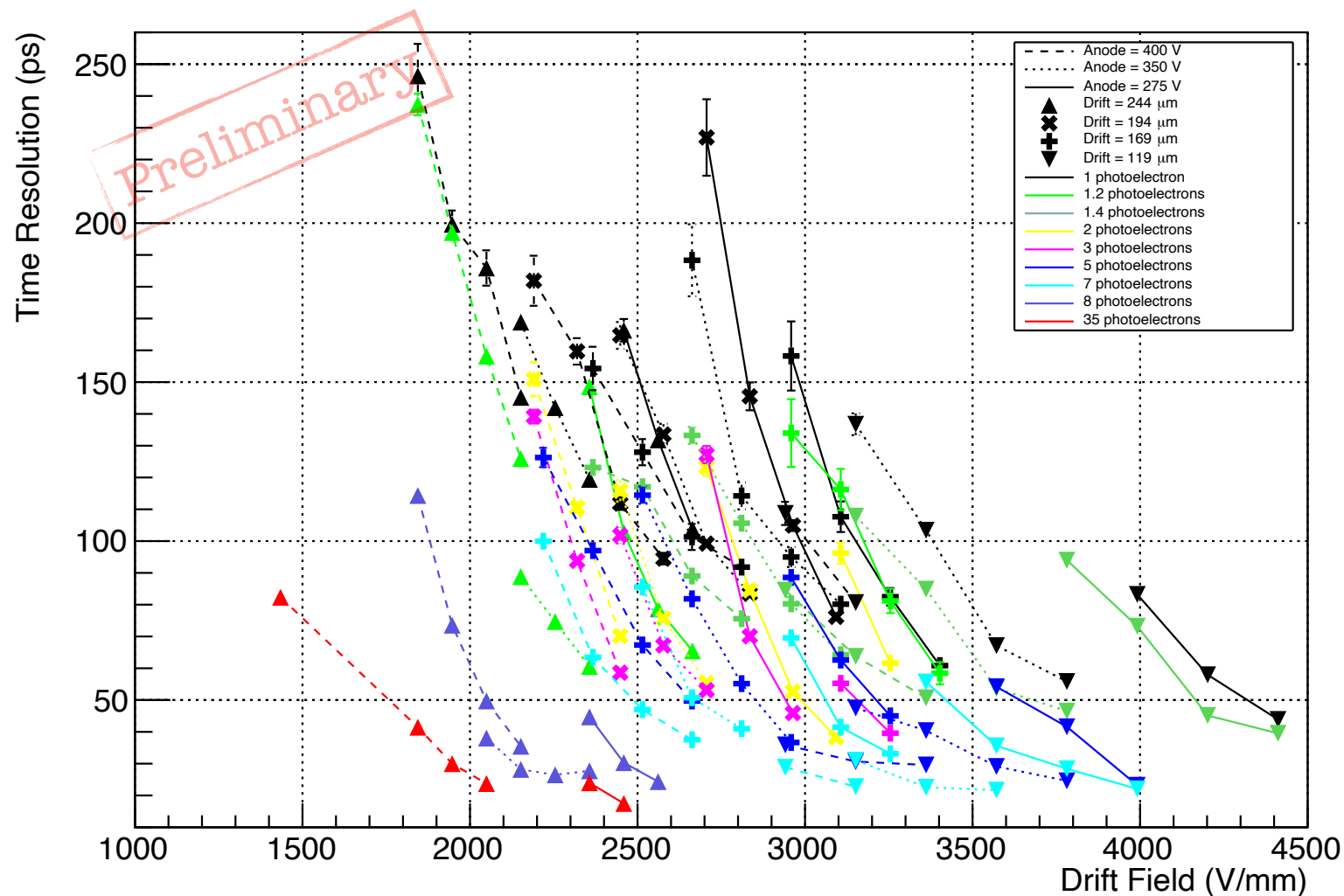
Removing attenuators for n p.e.

- Mean signal size is determined by a **Polya fit**
- 1 p.e. condition: additional **attenuators** are **not changing** the mean signal size
- Multi p.e. conditions: **removing** one attenuator after another resulting in **higher mean signal size**



Time resolution improves with drift distance and number of p.e.

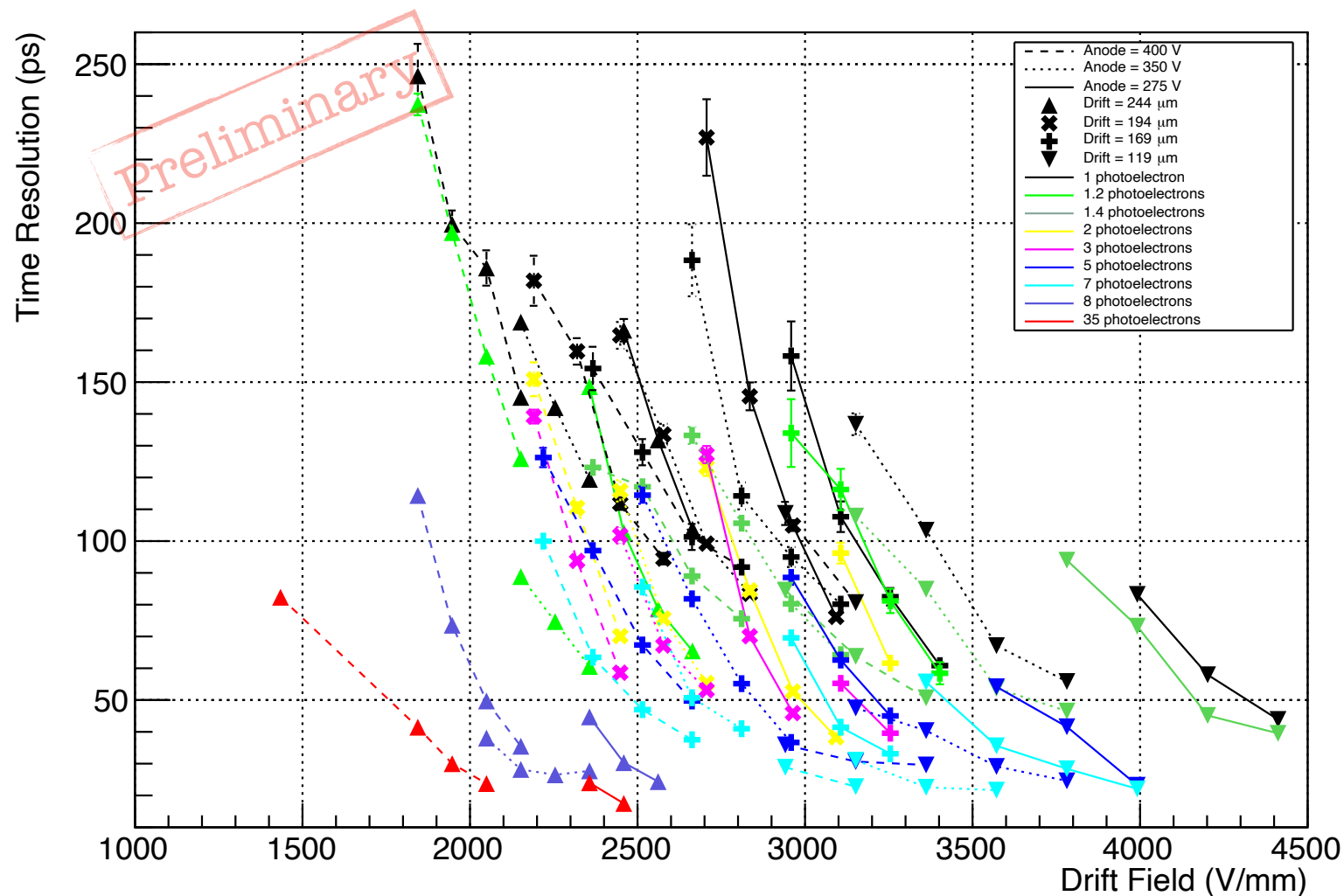
Time Resolution of all Settings



- Drift **field scan** performed for several drift distance and p.e. settings

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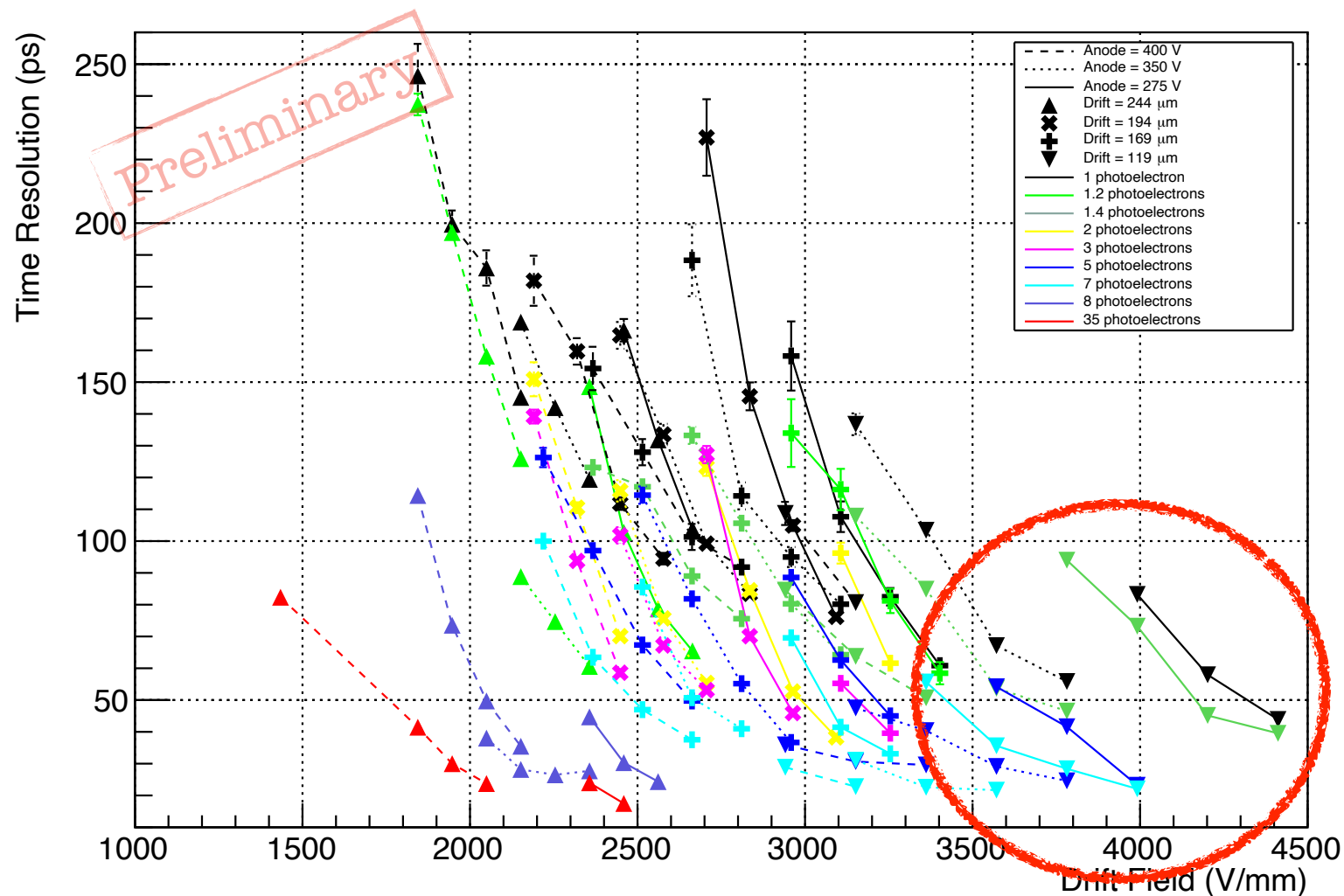


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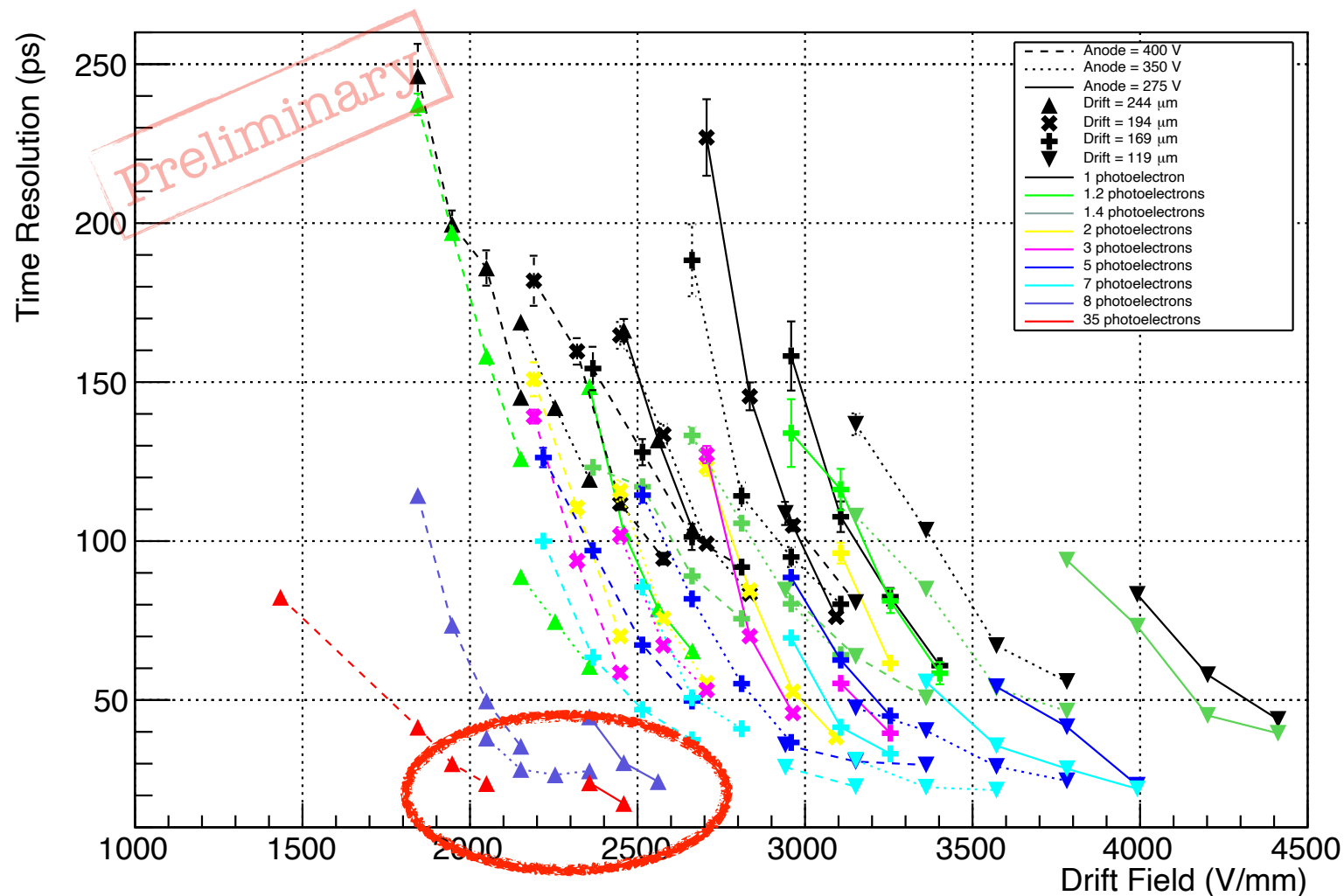
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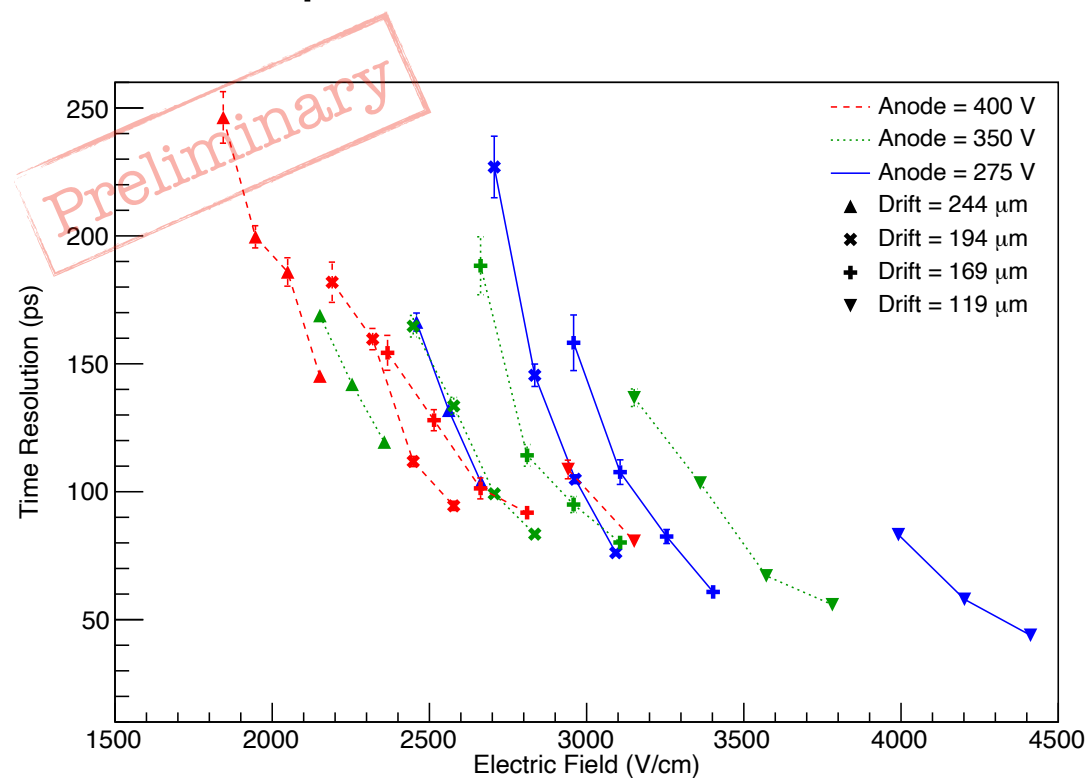
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- Time Resolution up to **~ 18 ps** for **many p.e.**

Time resolution improves with higher field in a shorter drift gap

1 p.e.; Anode: 128 μm

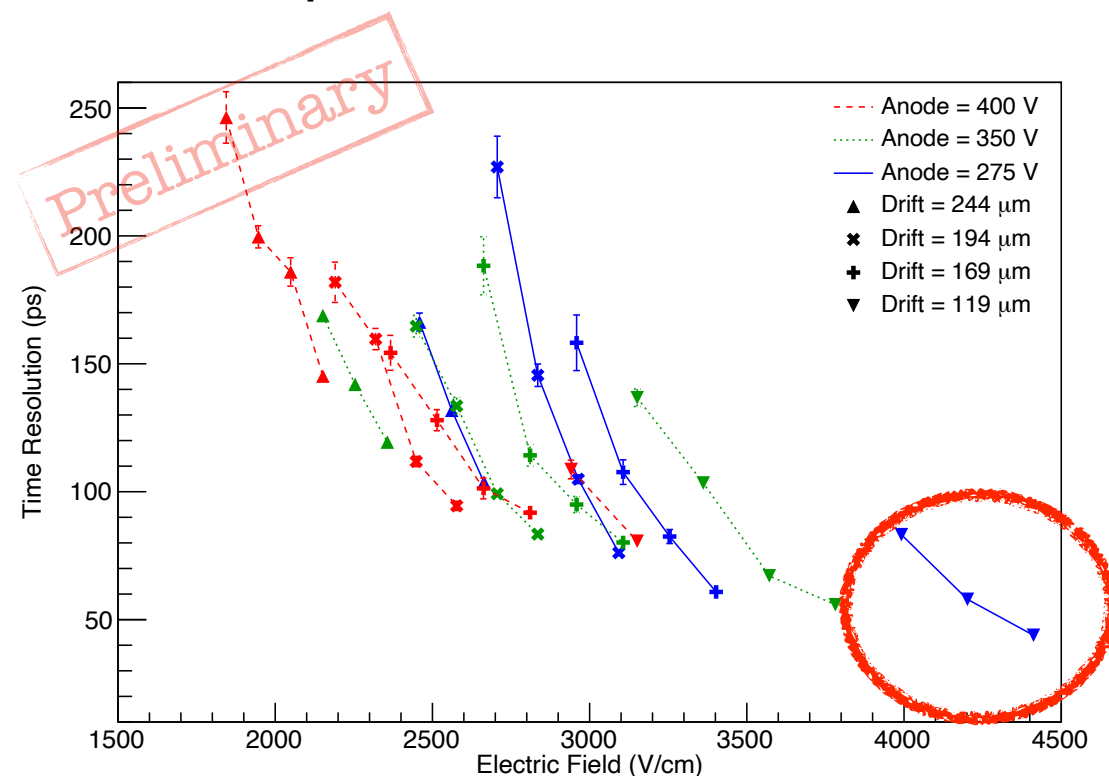


- Time resolution **improves** with **electric field**



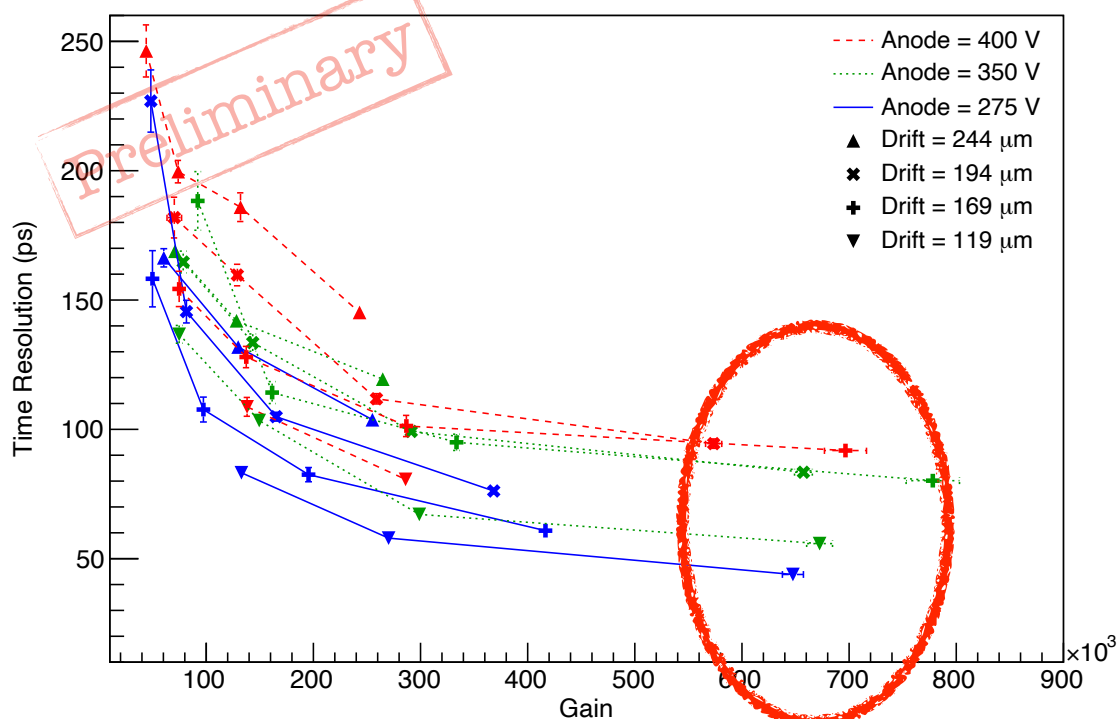
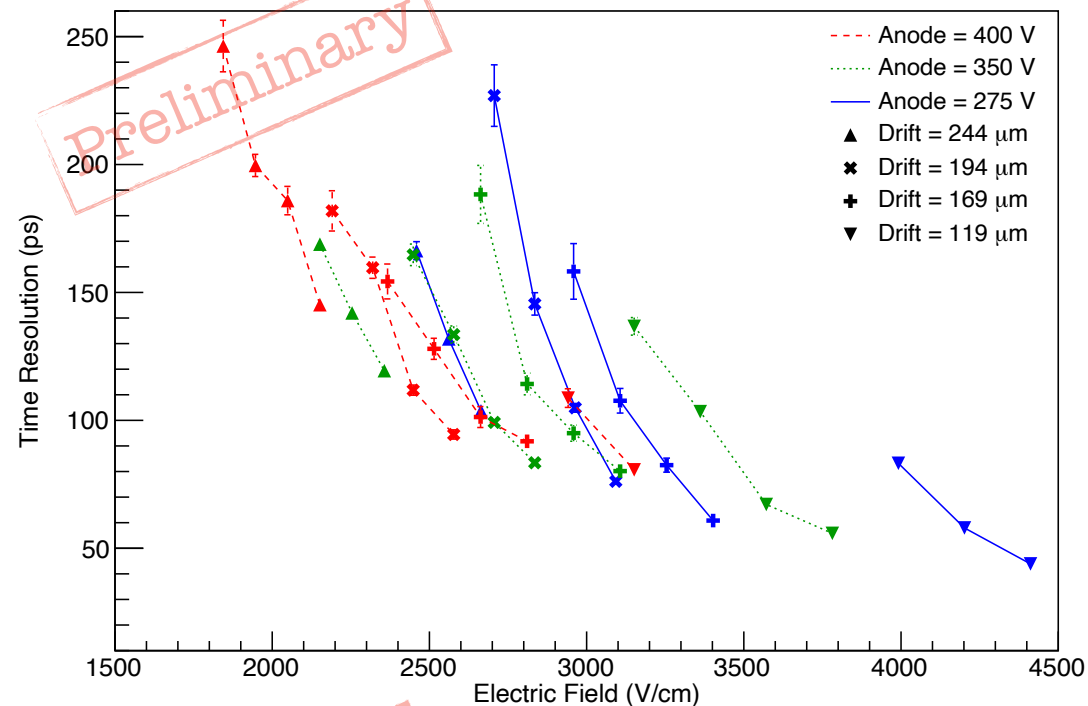
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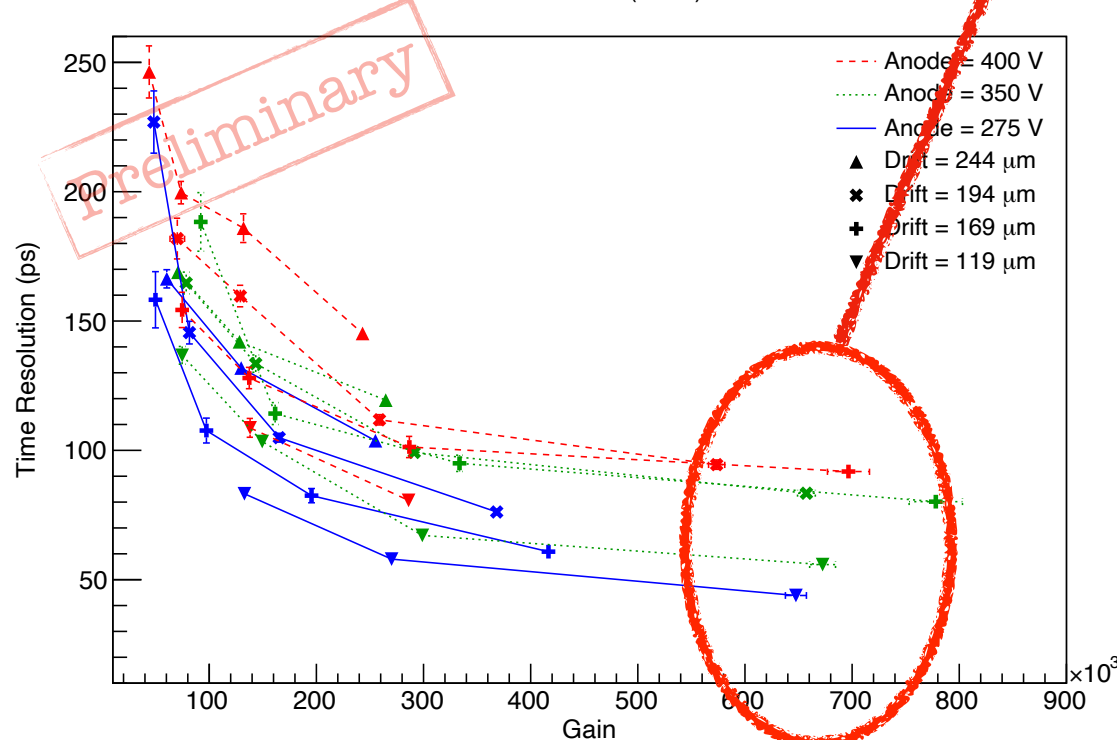
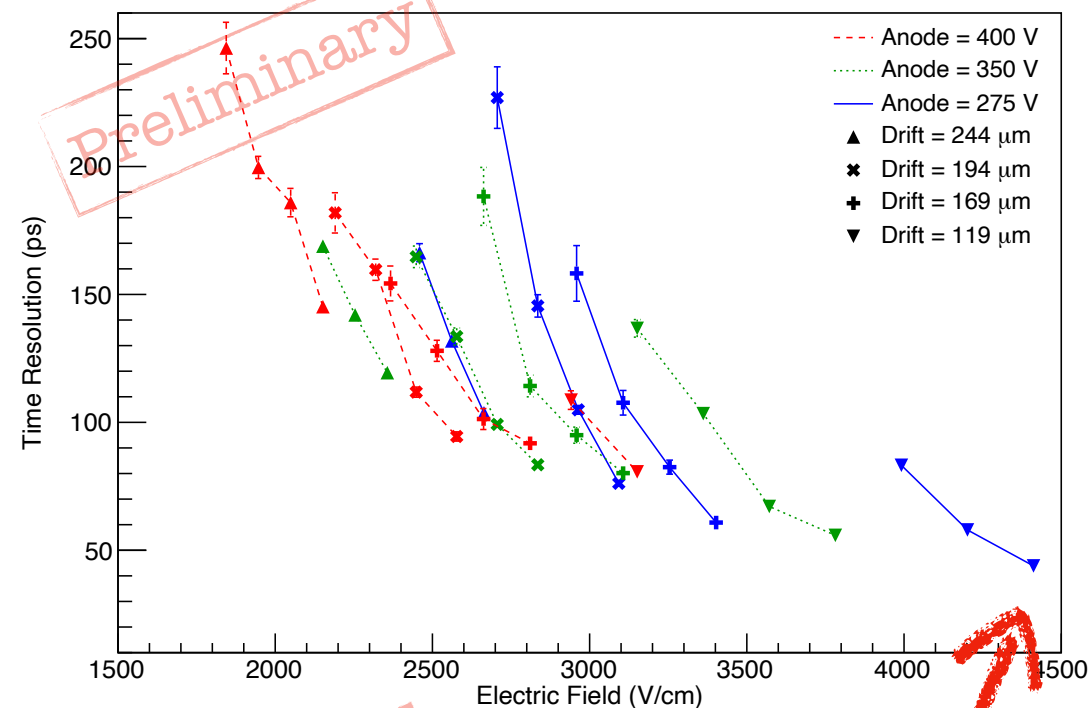
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- Time resolution **improves** with **electric field**
- Time resolution **< 50 ps at 1 p.e.** is possible with preamplification larger than amplification
- Smaller drift gap has **better performance at same gain**
 - ▶ Shorter **drift time** of the first electron **before** starting an **avalanche** gives a better time resolution

Gas mixture measurements in the Lab

- Up to now all measurements done with „COMPASS gas mixture“
 - ▶ 80 % Neon : 10 % Ethan : 10 % CF₄
- Understand **impact** of the gas mixture on PICOSEC-Micromegas

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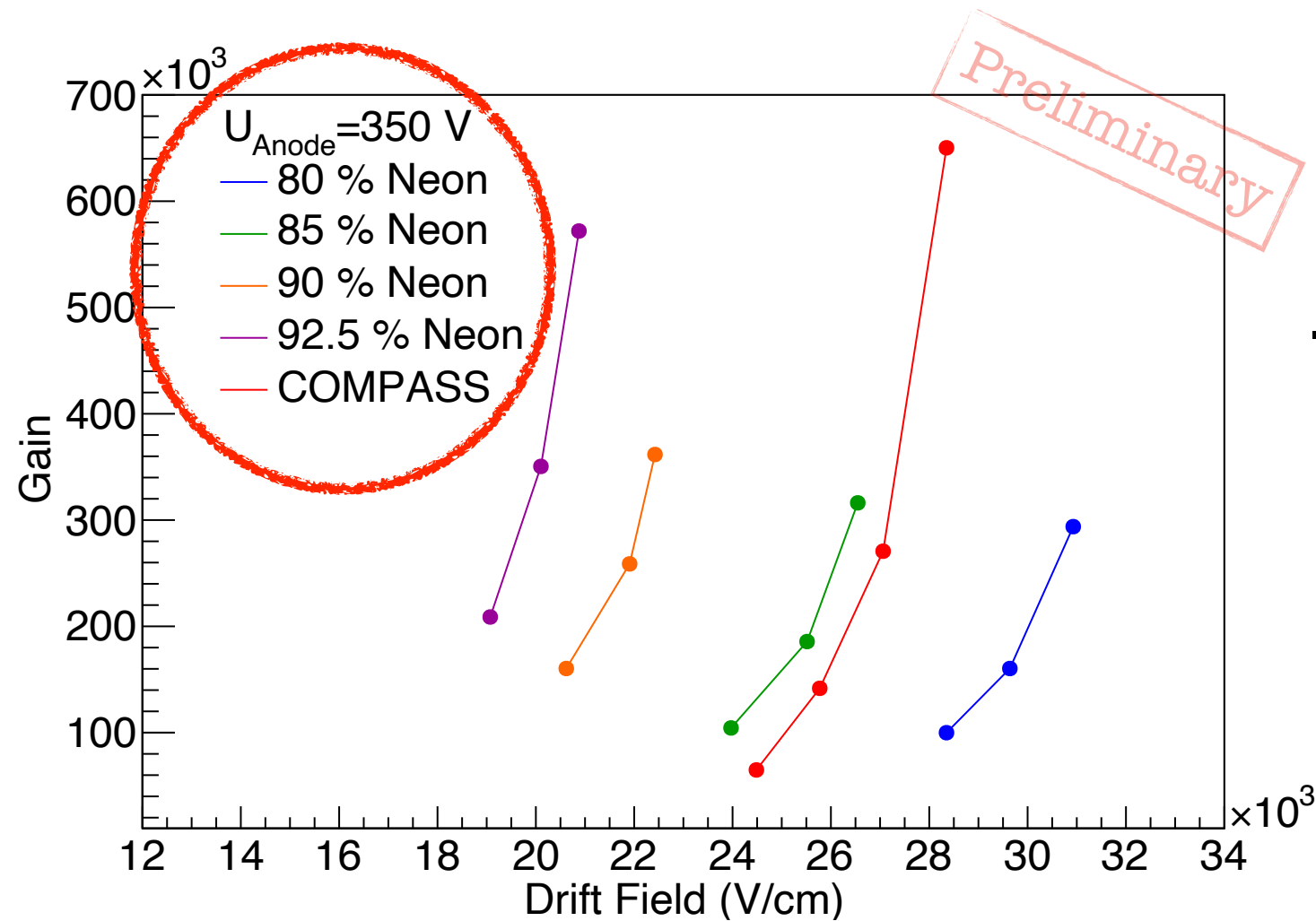
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 - ▶ Similar gain at lower field can give technical advantages

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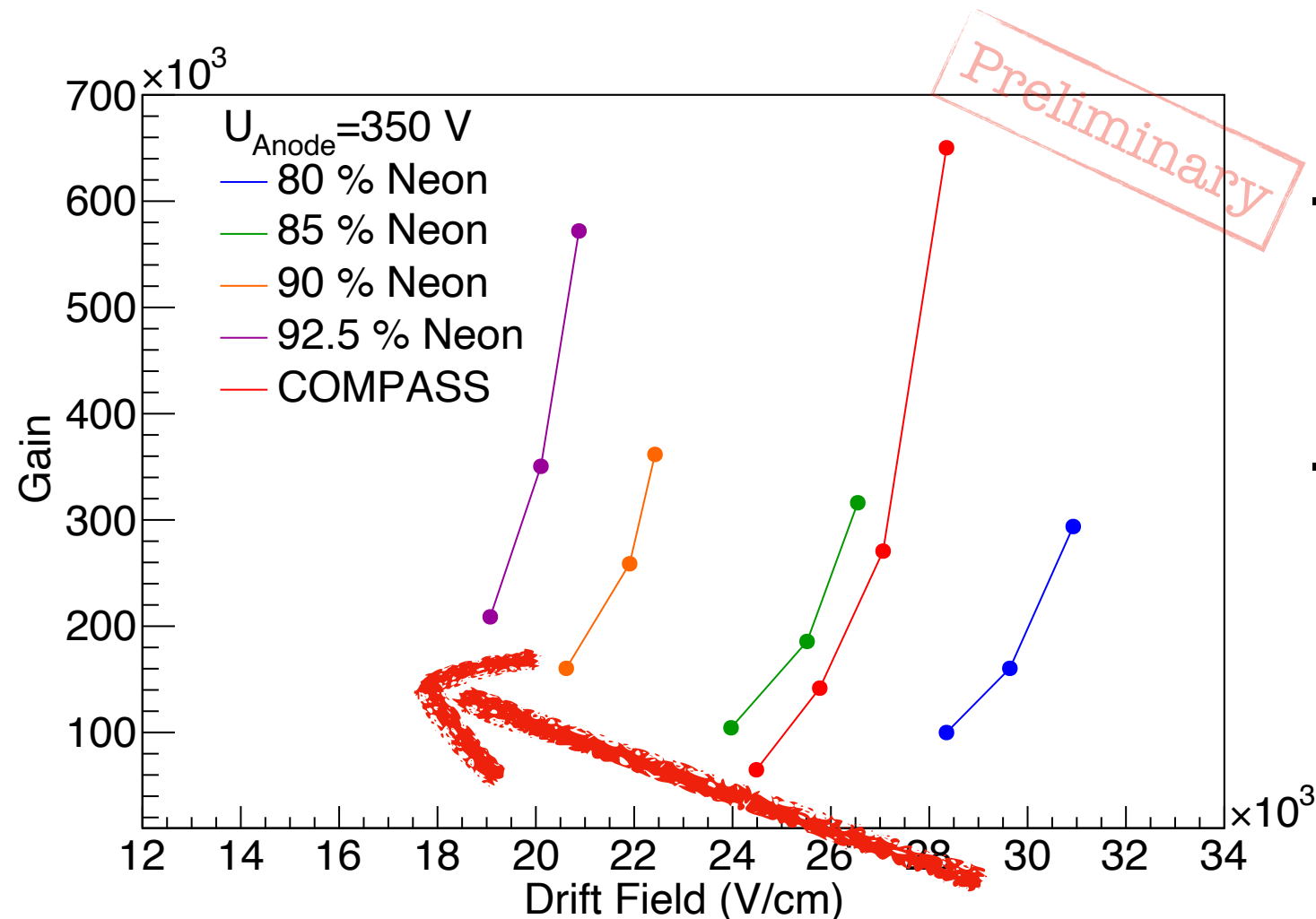
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- Lab measurements of the **gain** under **1 p.e. conditions**

Gain of different gas mixtures has been measured



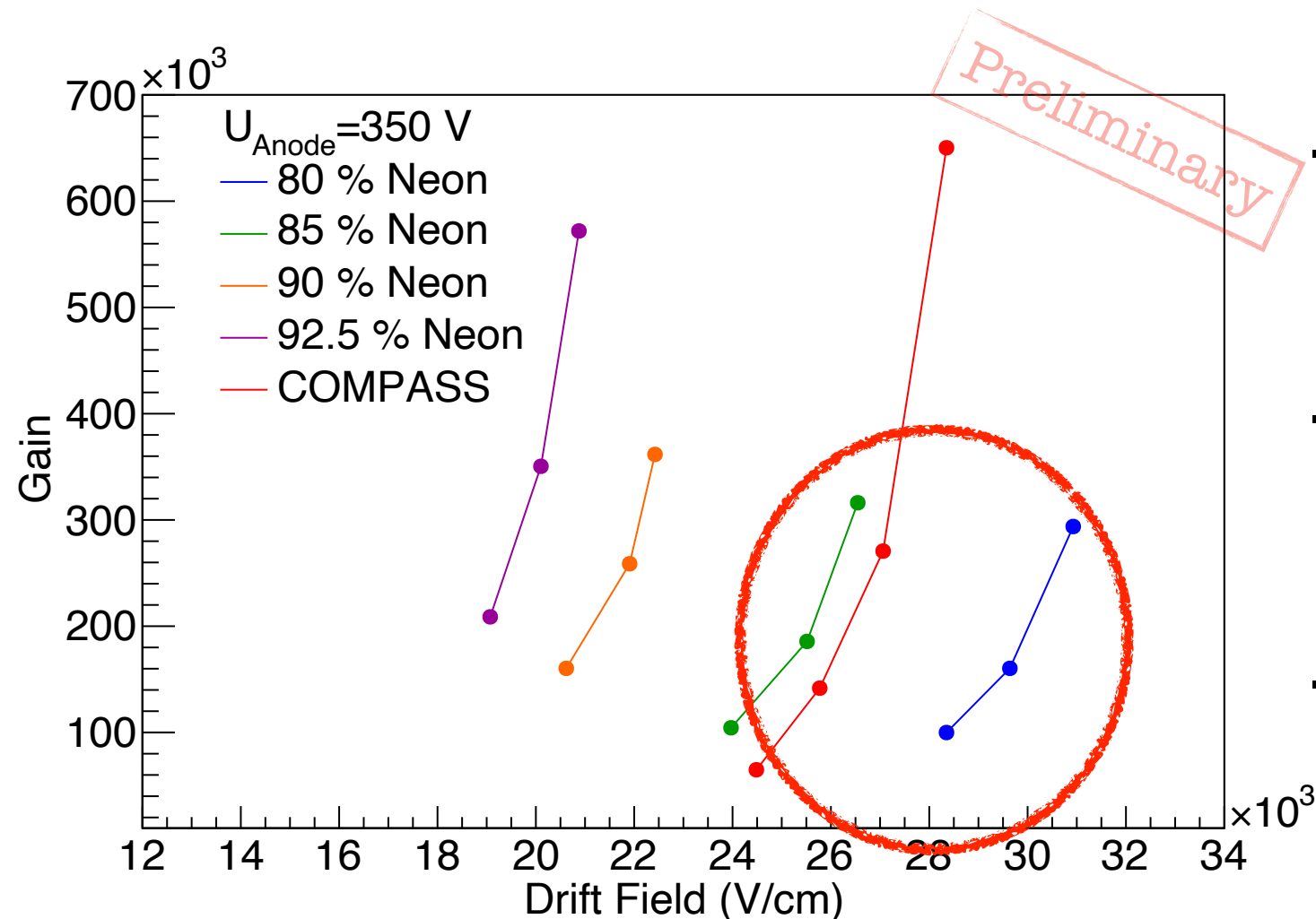
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Gain of different gas mixtures has been measured



- Neon - Ethan mixtures with different ratios are tested
- High Neon percentage gives higher gain at lower field
- CF₄ improves the gain compared to pure Ethan

COMPASS GAS

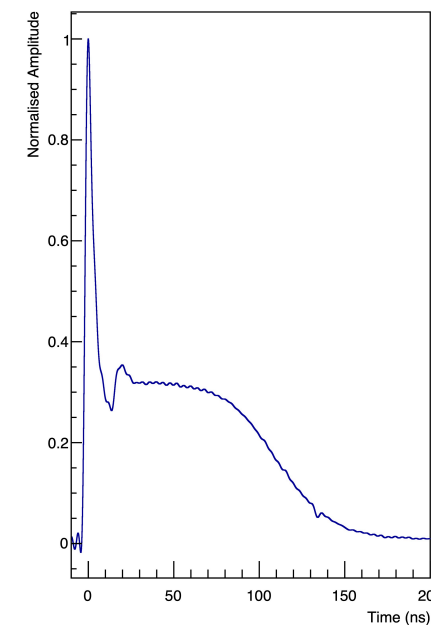
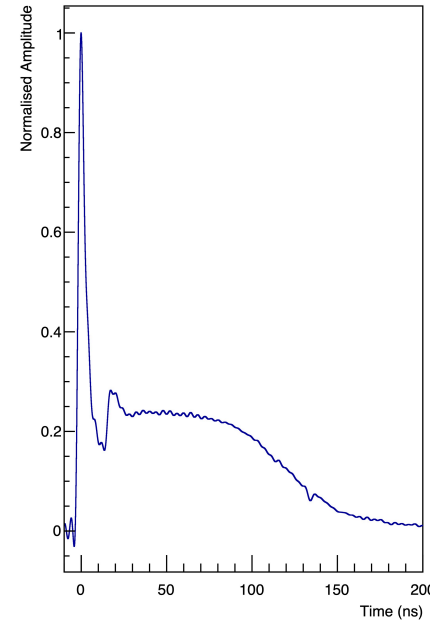
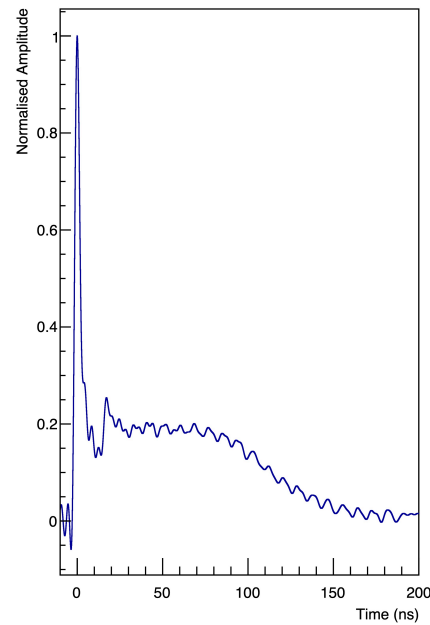
A:350V D:500V

Ne 80%

A:350V D:575V

Ne 85%

A:350V D:495V

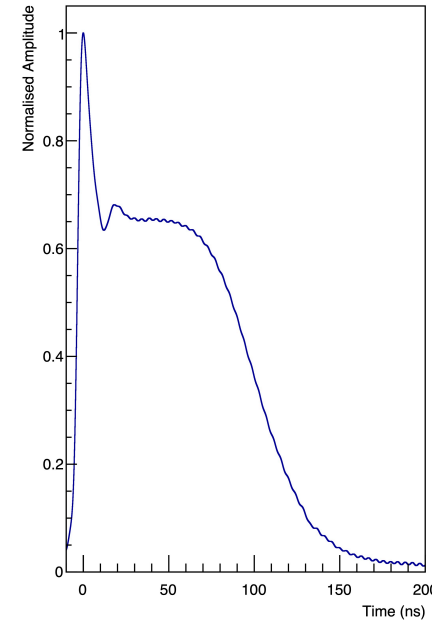
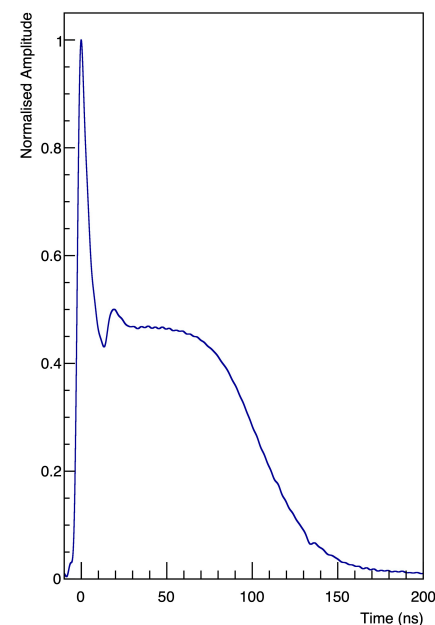


Ne 90%

A:350V D:425V

Ne 92.5%

A:350V D:390V



COMPASS GAS

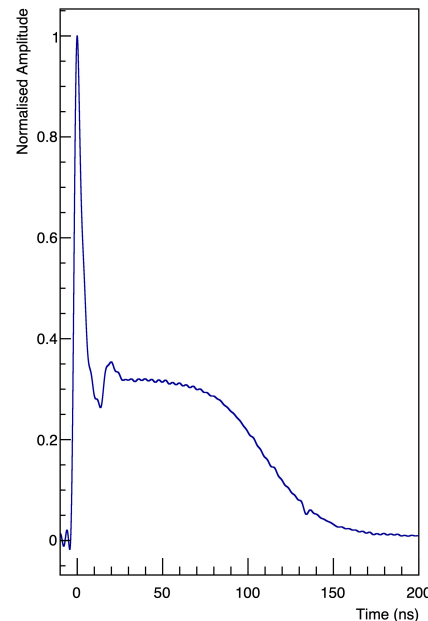
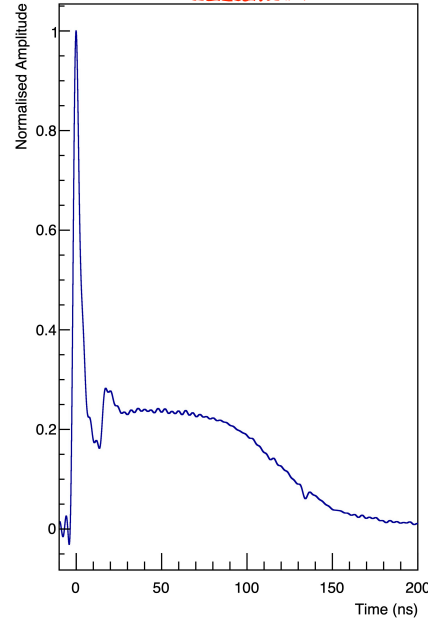
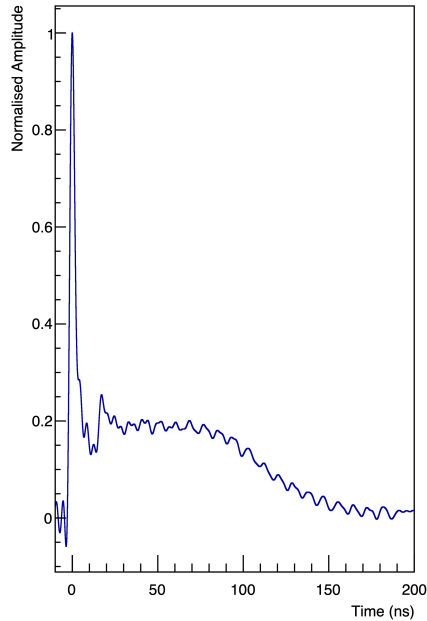
Ne 80%

Ne 85%

A:350V D:500V

A:350V D:575V

A:350V D:495V

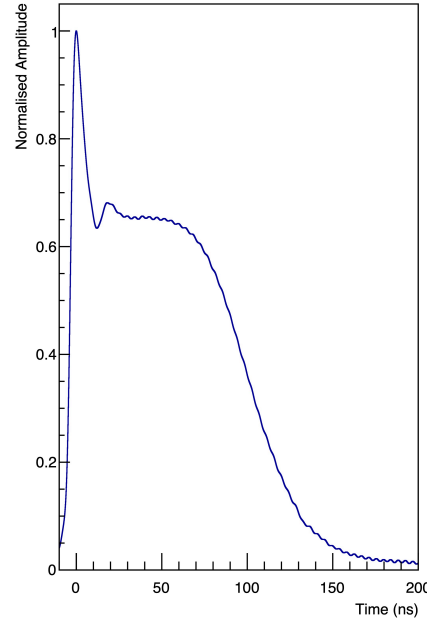
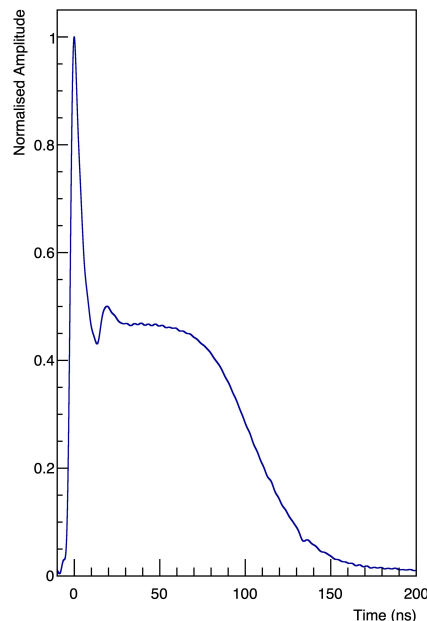


Ne 90%

Ne 92.5%

A:350V D:425V

A:350V D:390V



- Voltage settings are selected to provide the **same mean amplitude** at different gas mixtures
- **Lower voltage** are needed as more Neon provides a **higher gain**

COMPASS GAS

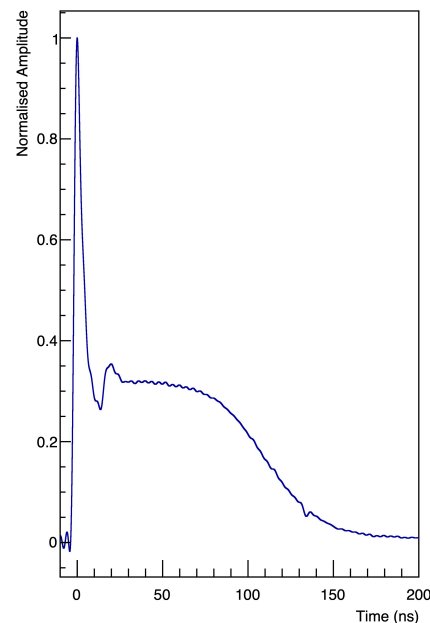
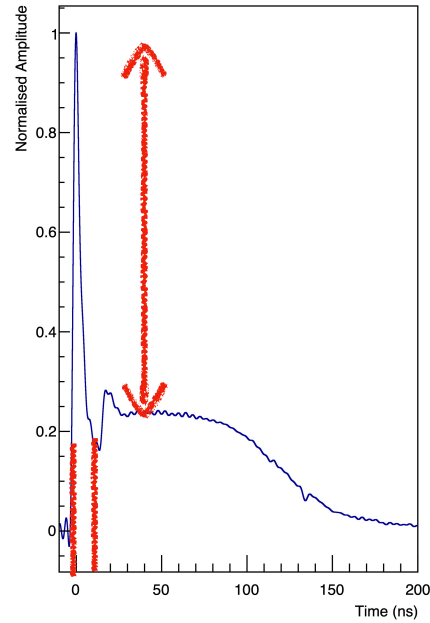
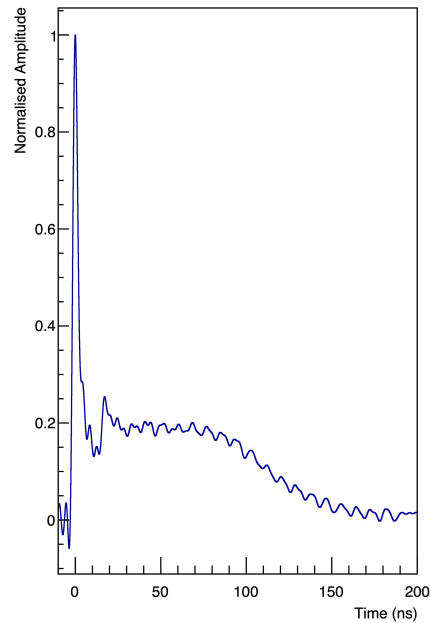
Ne 80%

Ne 85%

A:350V D:500V

A:350V D:575V

A:350V D:495V

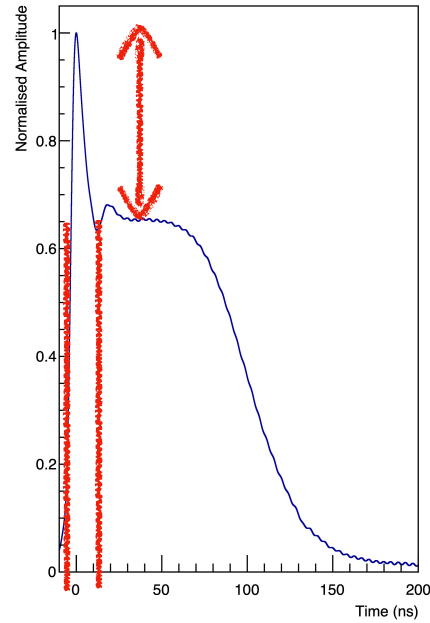
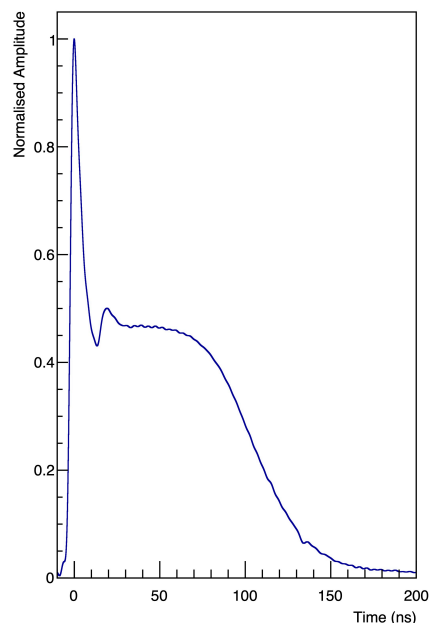


Ne 90%

Ne 92.5%

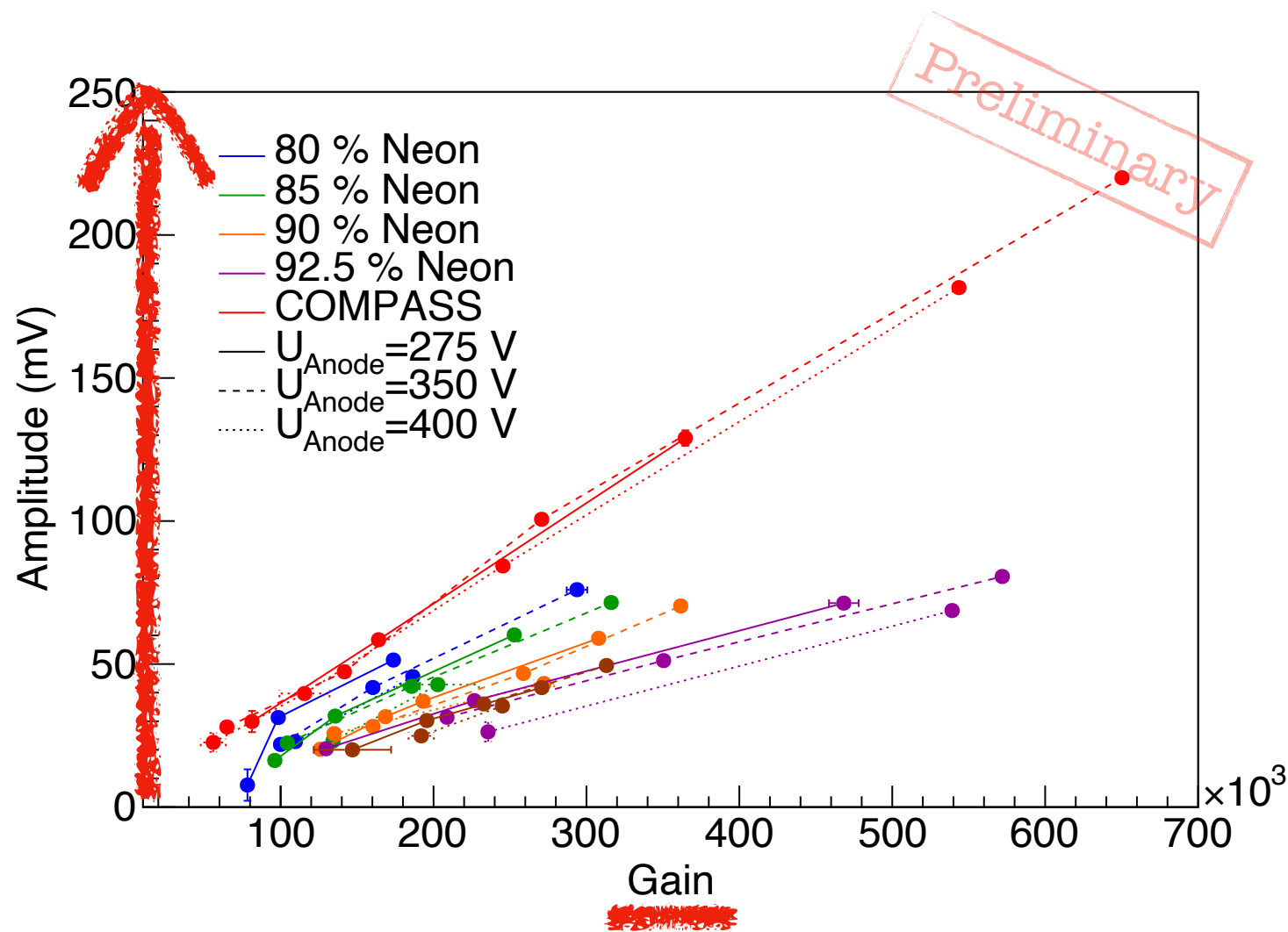
A:350V D:425V

A:350V D:390V



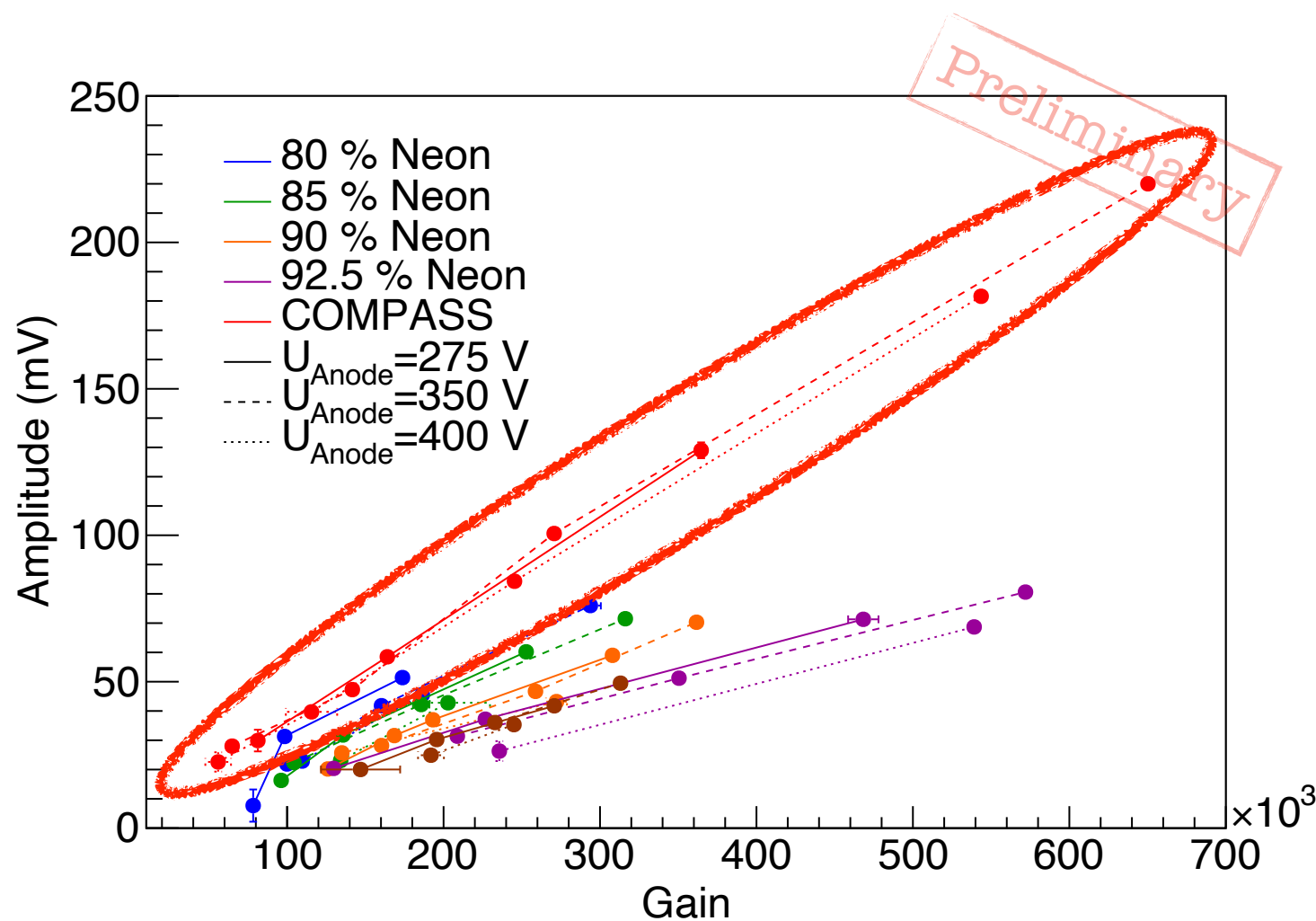
- Voltage settings are selected to provide the **same mean amplitude** at different gas mixtures
- **Lower voltage** are needed as more Neon provides a **higher gain**
- **Ratio** between electron **peak amplitude** and ion **tail amplitude** is rising at higher Neon mixture
 - ▶ **Electron peak is widening**

Amplitude vs. gain ratio gives hint about signal shape



- Sharper electron peaks have higher amplitude at the same signal charge

Amplitude vs. gain ratio gives hint about signal shape



- Sharper electron peaks have higher amplitude at the same signal charge
- COMPASS gas mixture signals are given steeper rising edges than the other mixtures
- Probably better time resolution
- To be verified in the Laser

What is next ...

What is next ...

- Further Laser measurements
 - Time performance test of different gas mixtures and pressures

What is next ...

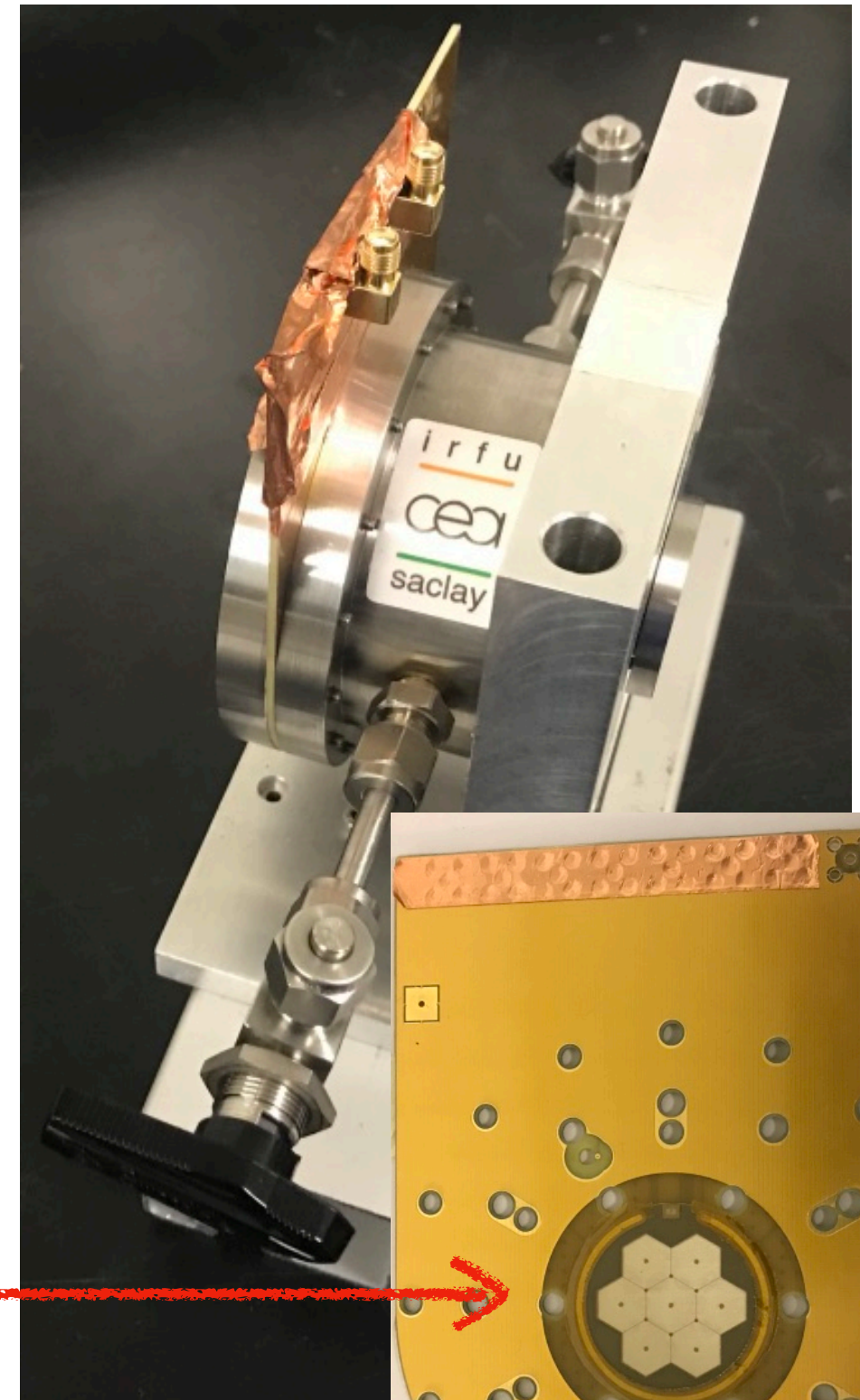
- Further **Laser measurements**
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- Research for **photocathode materials** (DLC, B4C, secondary emitter, ...)
 - ➔ Only **few p.e. needed** for target time Resolution when **<50 ps @ 1 p.e.**

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 - Irradiation and Q.E. measurements at USTC
 - ASSET chamber at CERN
 - Cosmic bench at CEA

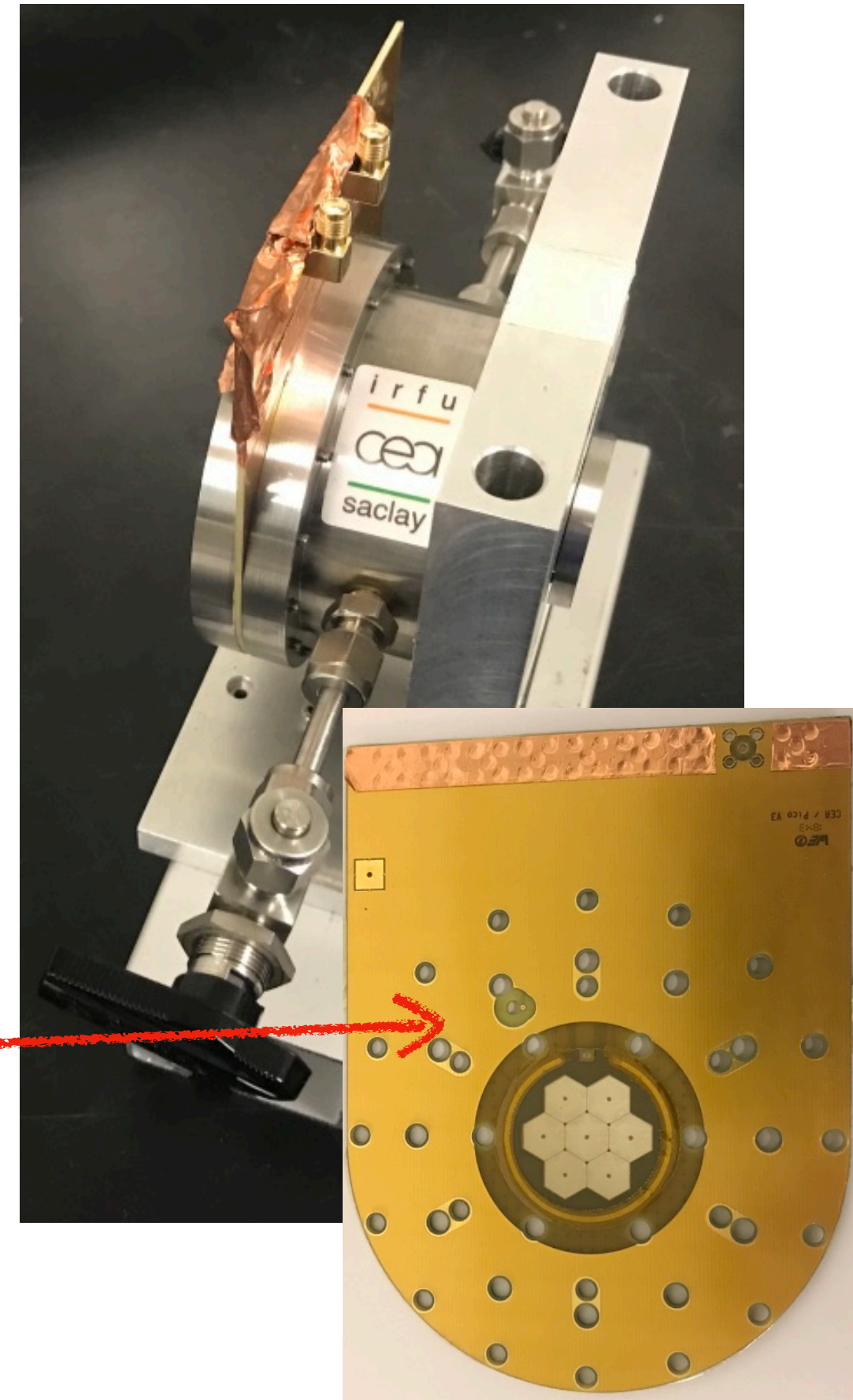
What is next ...

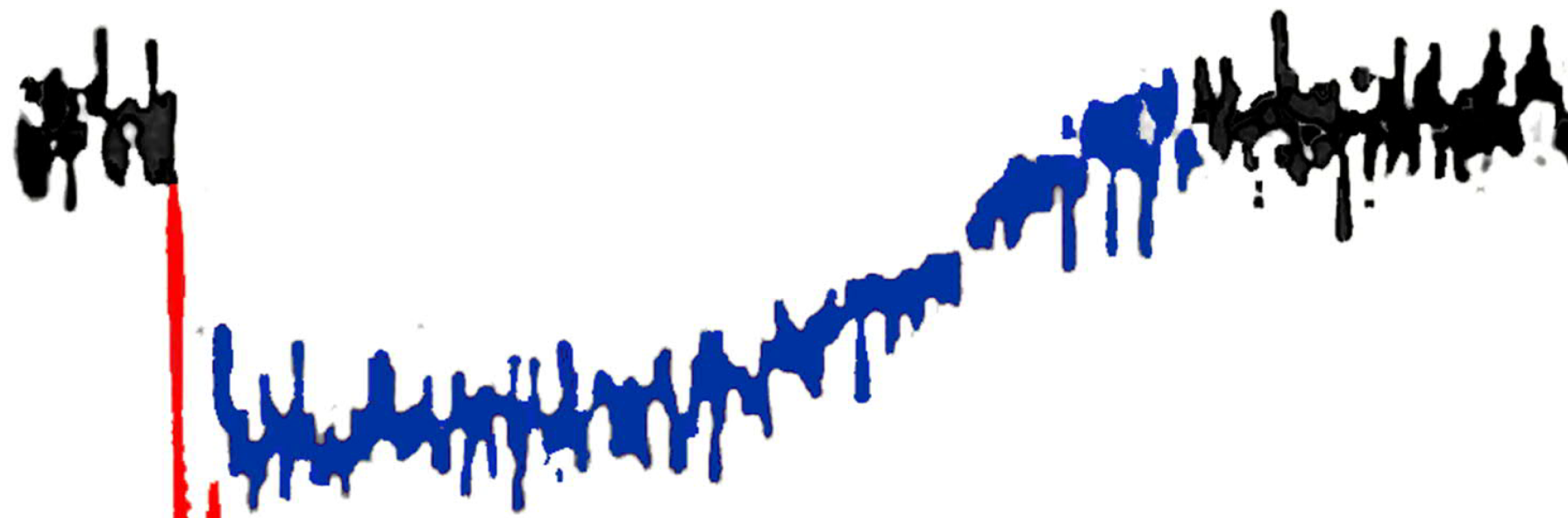
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What is next ...

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 - **Time performance** test of different **gas mixtures** and **pressures**
- Research for **photocathode materials** (DLC, B4C, secondary emitter, ...)
 - ➔ Only **few p.e. needed** for target time Resolution when **<50 ps @ 1 p.e.**
 - Irradiation and Q.E. measurements at USTC
 - ASSET chamber at CERN
 - Cosmic bench at CEA
- Development of a **resistive multipad** Picosec chamber
- Detailed simulation and modelling at AUTH
- (Embedded) **electronics** for segmented readout





P I C O S E C

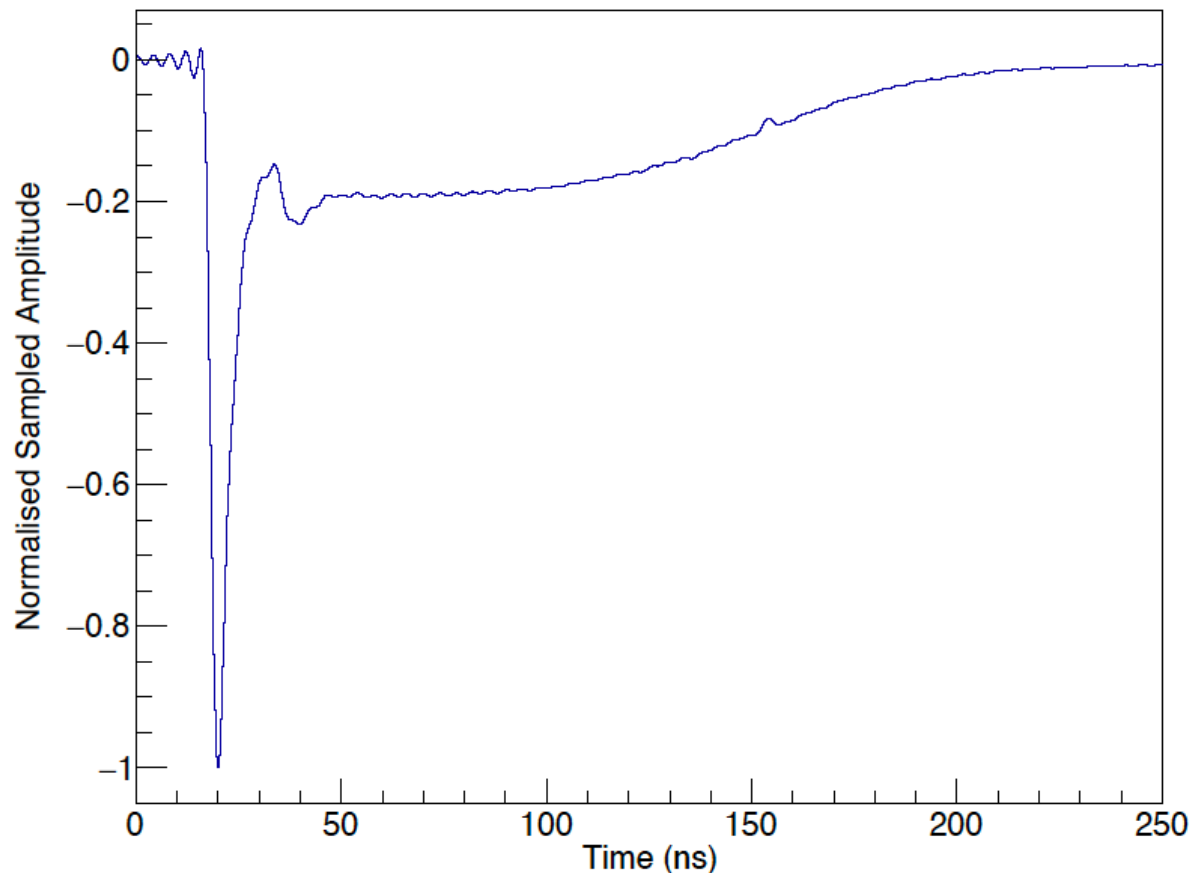
Micromegas

Backup

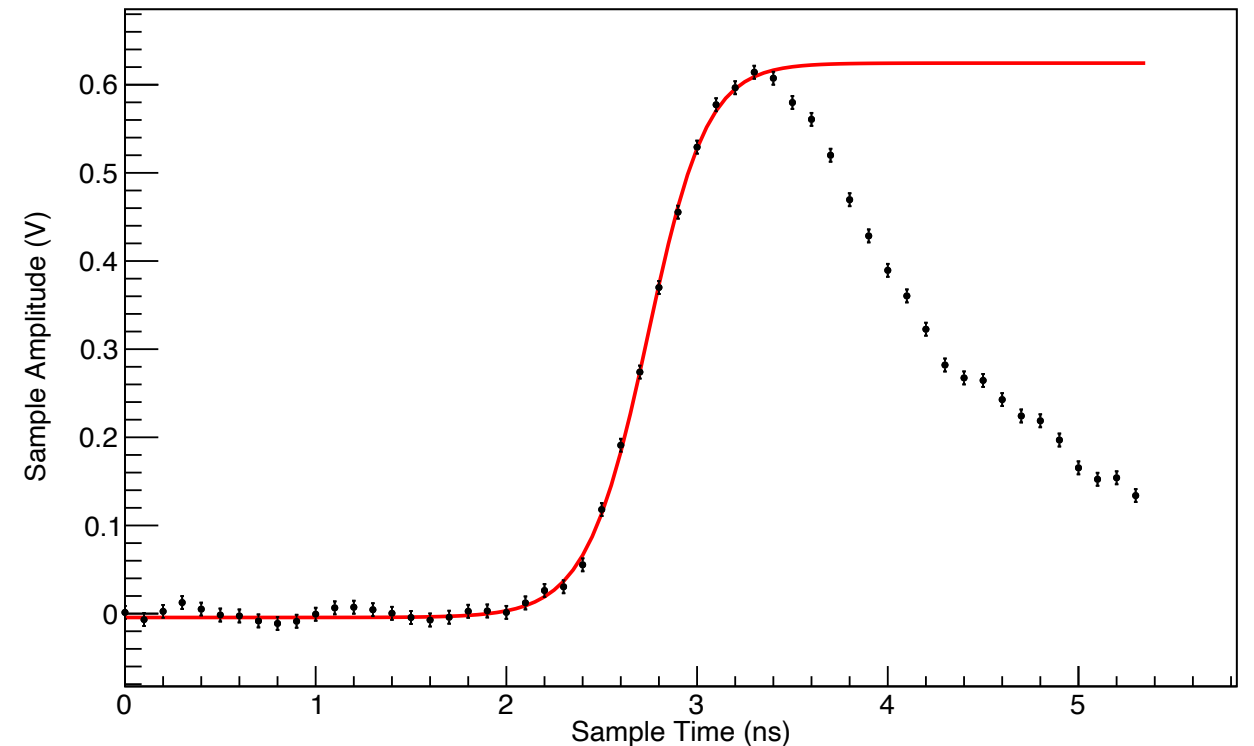
Calculating the Time Resolution

1. Sigmoid fit of the rising edge

Digitised PICOSEC-Micromegas signal



Generalised sigmoid fit of the rising edge



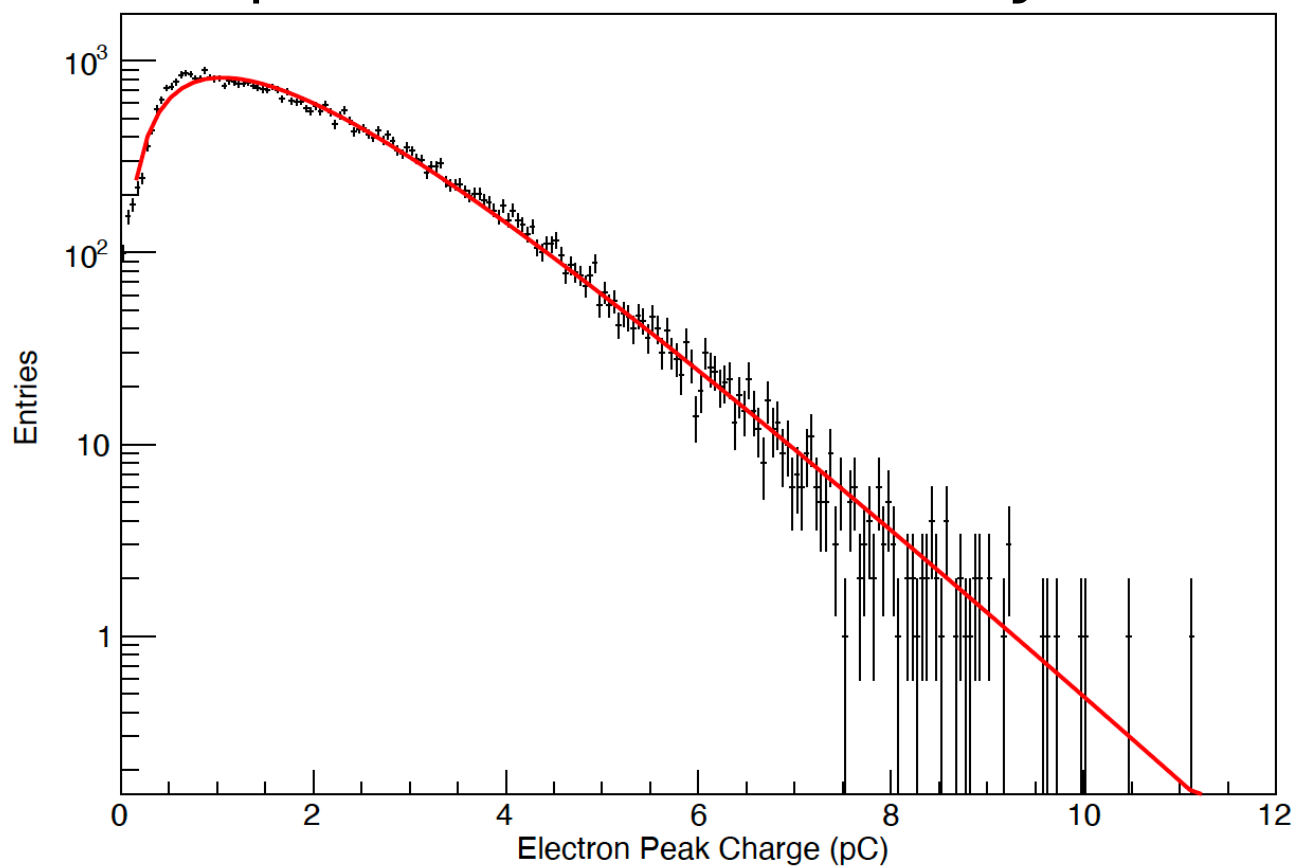
The SAT calculation of a **continuous function** is more **accurate** than from discrete values
➡ The rising edge of the electron peak is **fitted** by a generalised **sigmoid function**

$$S(t) = \frac{P_0}{(1 + P_1 e^{-P_2(t-P_3)})^{P_4}}$$

Calculating the Time Resolution

2. Polya fit of the Charge Distribution

E-peak distribution and Polya fit



- The **integral** of the electron **peak** is giving the **charge**
- Charge **distribution** is fitted by Polya function

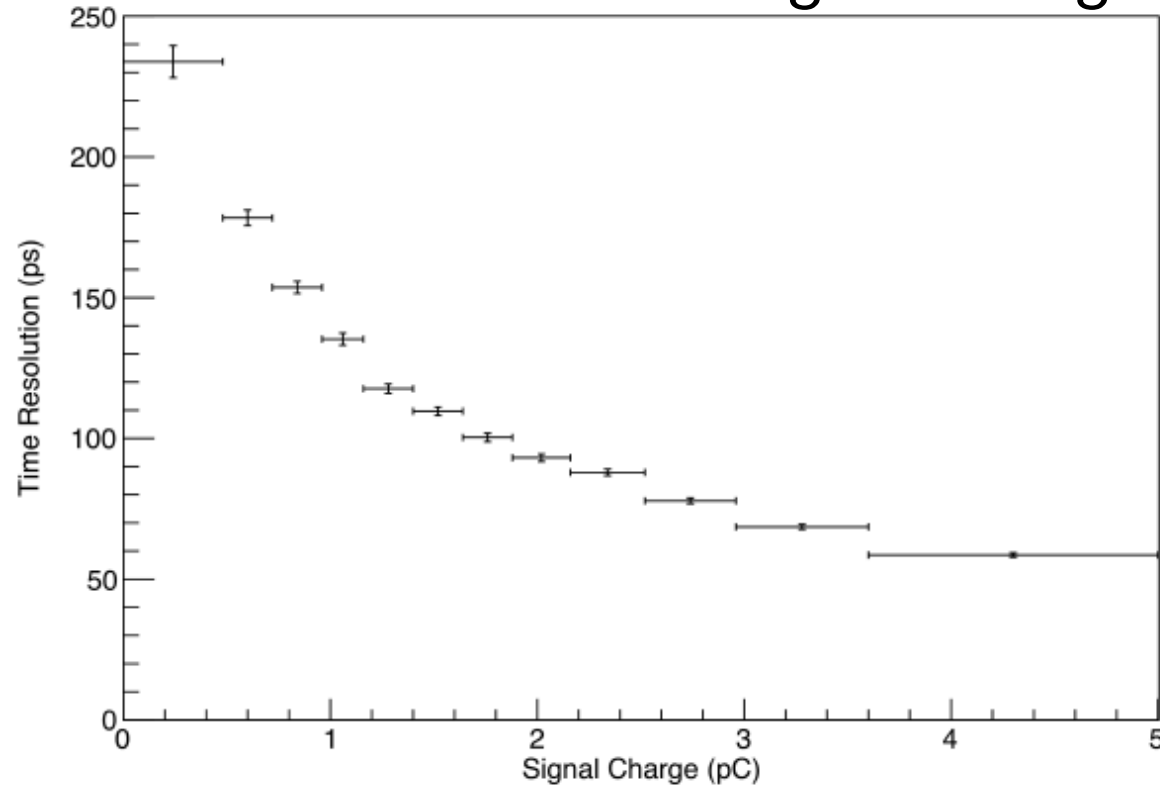
$$P(Q; c; \Theta; \bar{Q}) = \frac{c}{Q} \frac{(\Theta + 1)^{\Theta+1} (Q/\bar{Q})^{\Theta}}{\Gamma(\Theta + 1)} e^{-(\Theta+1)Q/\bar{Q}}$$

- Fit is giving information of **mean signal charge**
- Needed for calculating p.c. **light yield**

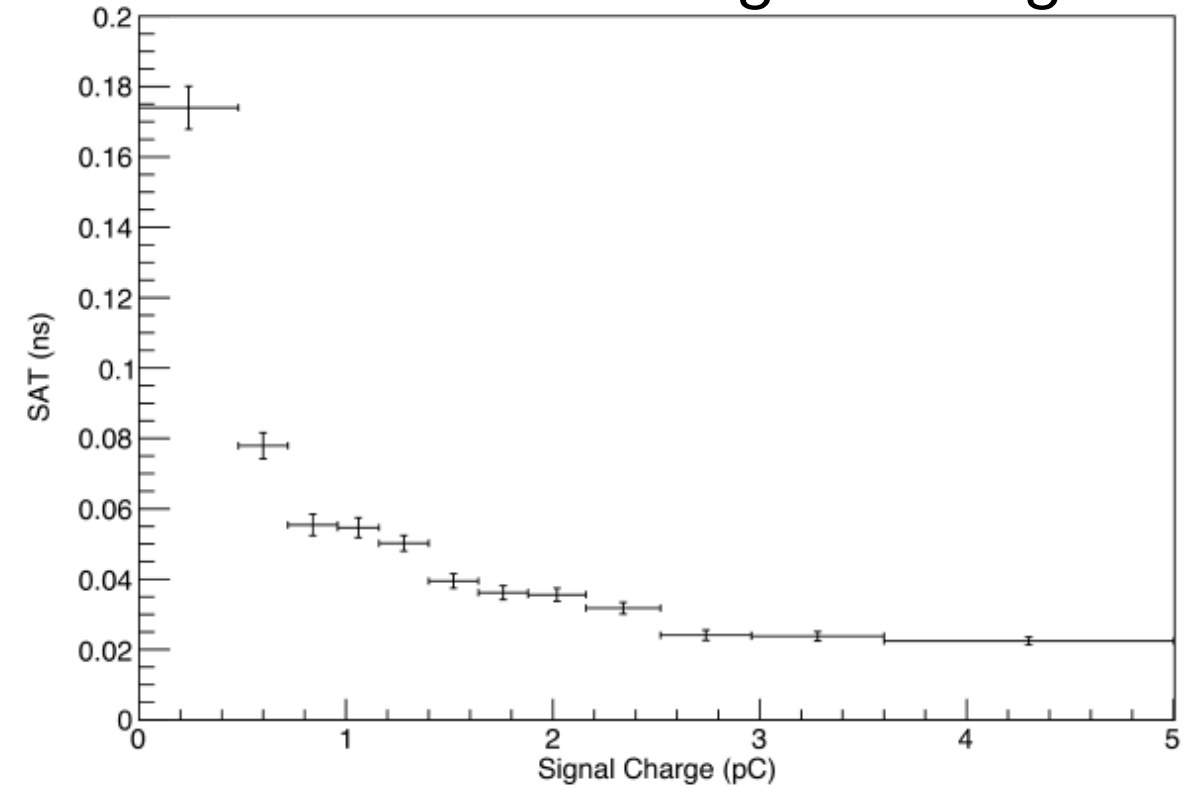
Calculating the Time Resolution

3. Slewing Correction

Time resolution vs. Signal Charge



Mean SAT vs. Signal Charge



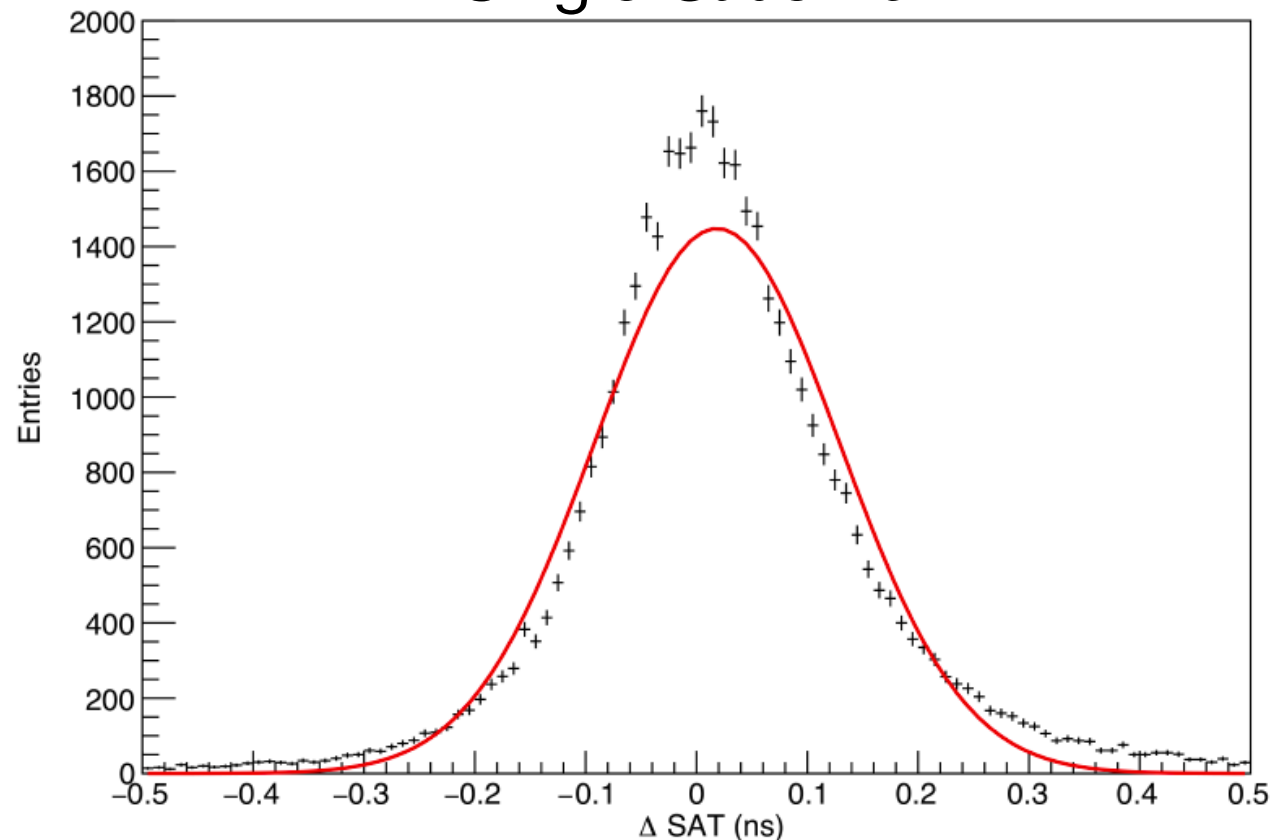
- Time resolution **improves** and mean SAT moves at **higher signal charge**
- Binning is selected according to the **Polya fit**
- Total time resolution is calculated by the **convolution** of the individual time resolutions

$$\sigma^2 = \sum_{i=1}^n a_i \sigma_i^2 + \sum_{i=1}^n \sum_{j=i+1}^n a_i \times a_j \times (\sigma_i^2 + \sigma_j^2 + (\mu_i - \mu_j)^2)$$

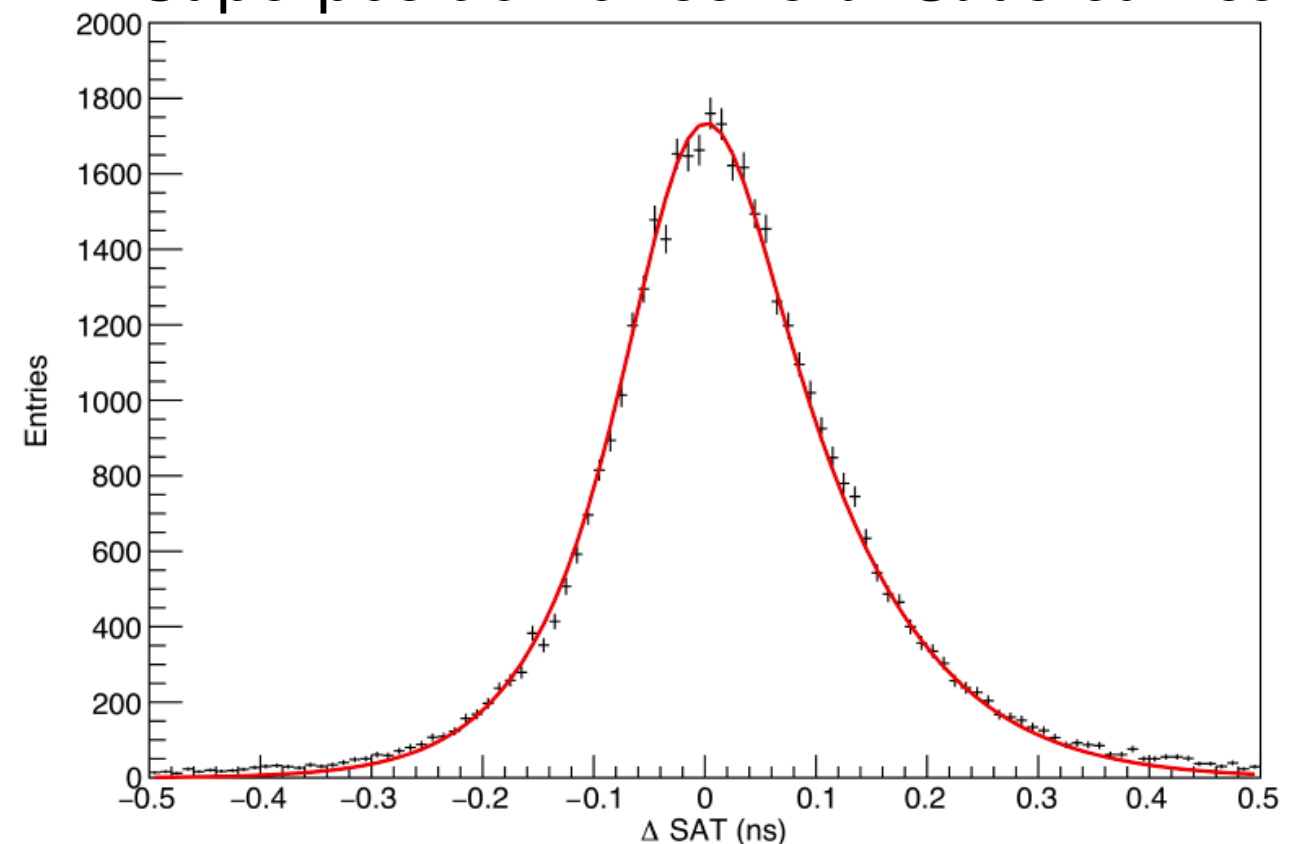
Calculating the Time Resolution

4. Multi Gaus fit

Single Gaus fit



Superposition of several Gaus curves

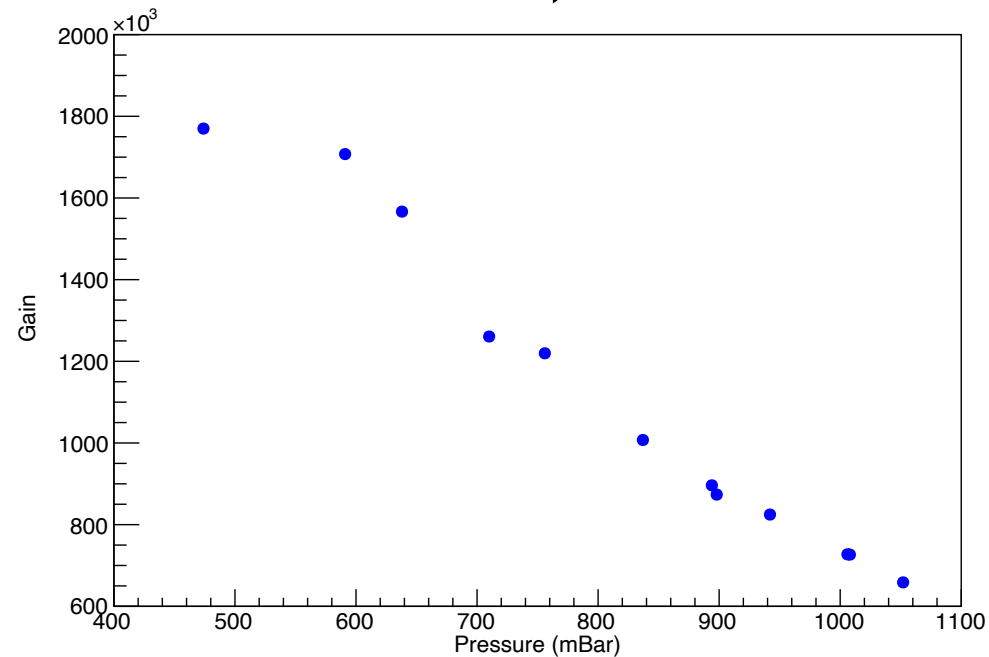


- Time resolution is determined by the sigma of the SAT difference between the DUT and a t0 reference
- Correction of the slewing effect improves the fit of the distribution

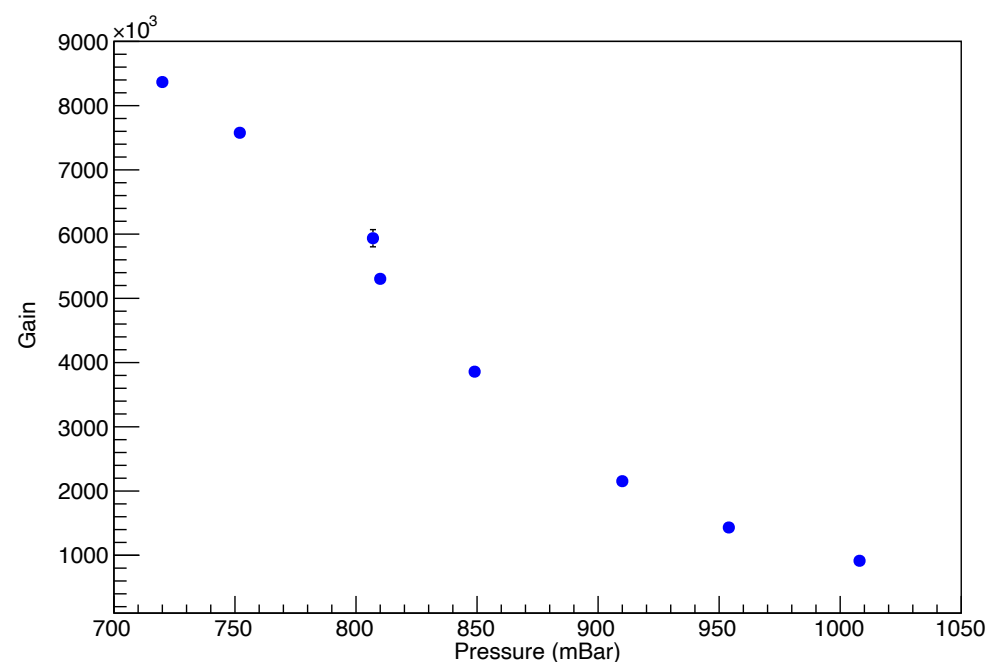
$$\sigma^2 = \sum_{i=1}^n a_i \sigma_i^2 + \sum_{i=1}^n \sum_{j=i+1}^n a_i \times a_j \times (\sigma_i^2 + \sigma_j^2 + (\mu_i - \mu_j)^2)$$

Gain rises and saturates at lower pressure

Anode 500 V; Drift 100 V

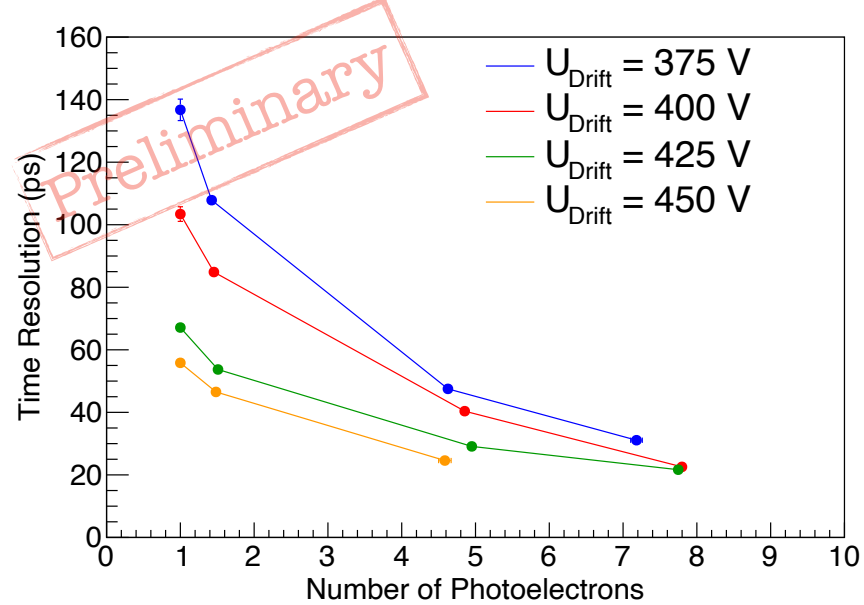


Anode 275 V; Drift 450 V

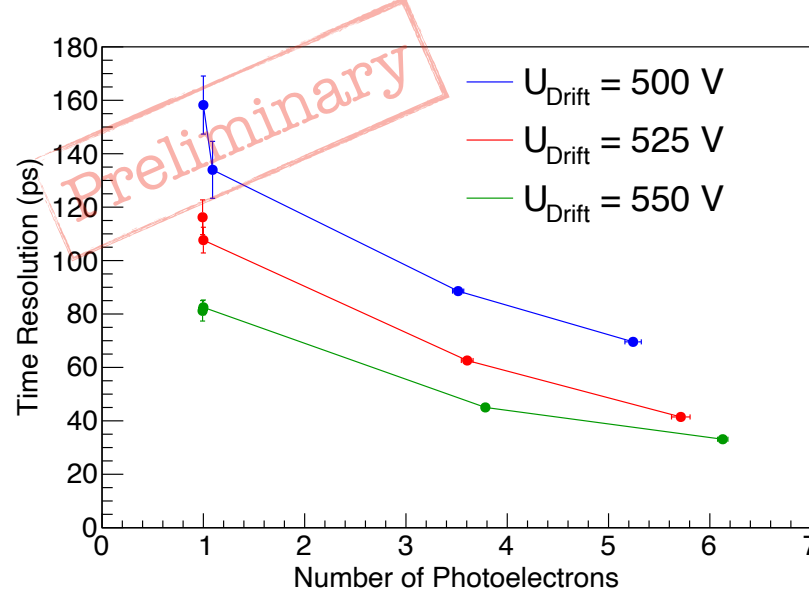


- Measurement done for COMPASS gas only
- Gain saturates at lower pressure
- Natural atmospheric pressure fluctuation can affect gain and thus time resolution
- Time resolution measurements at different gas pressures are planned

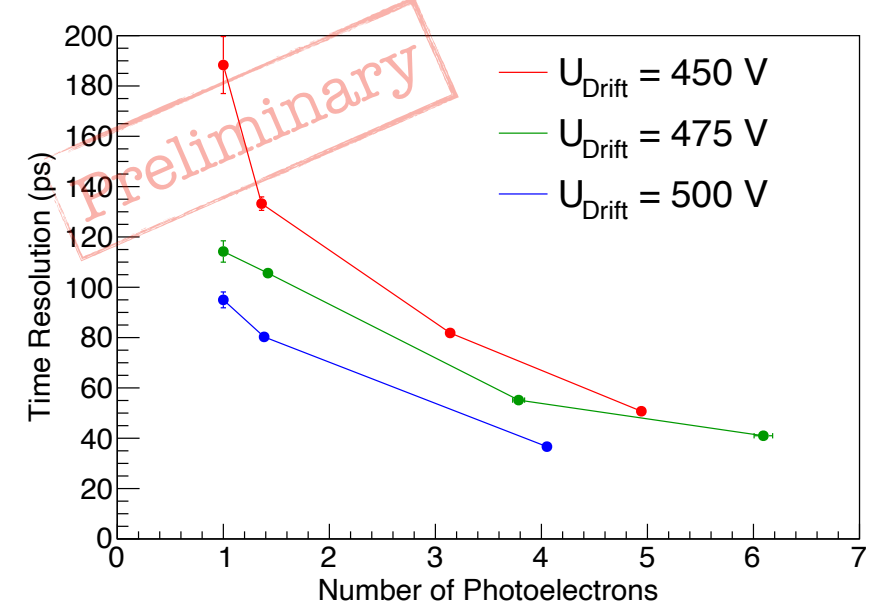
119 μm ; Anode 350 V



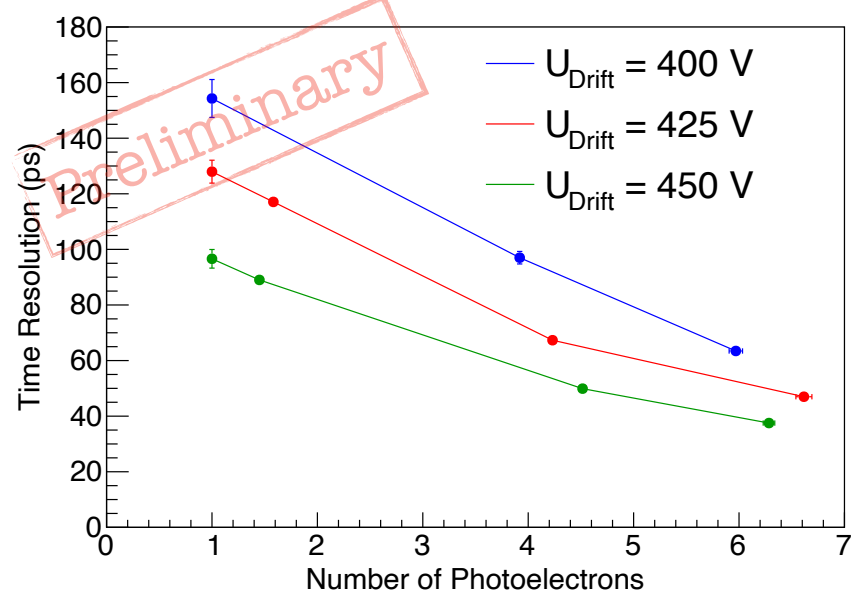
169 μm ; Anode 275 V



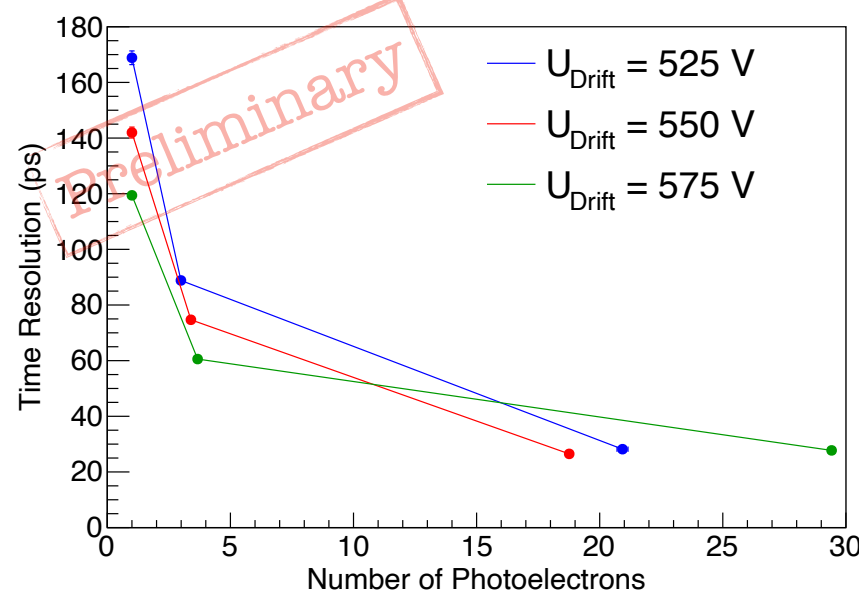
169 μm ; Anode 350 V



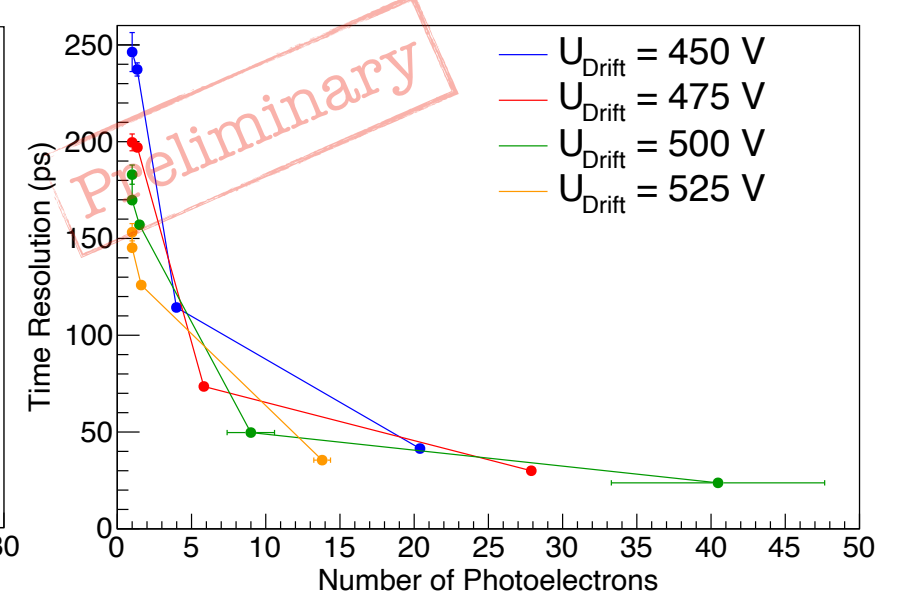
169 μm ; Anode 400 V



244 μm ; Anode 350 V



244 μm ; Anode 400V



Ne 80%

A:350V D:575V

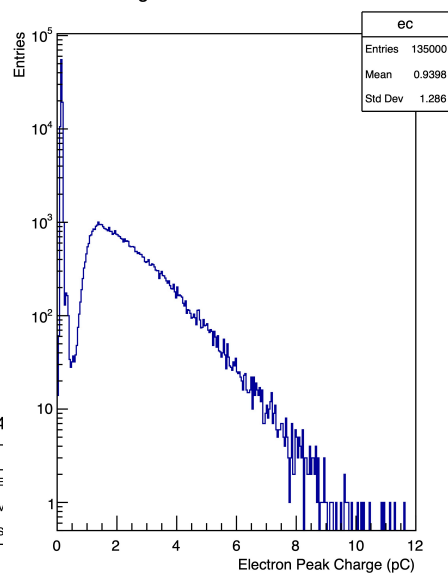
Ne 85%

A:350V D:495V

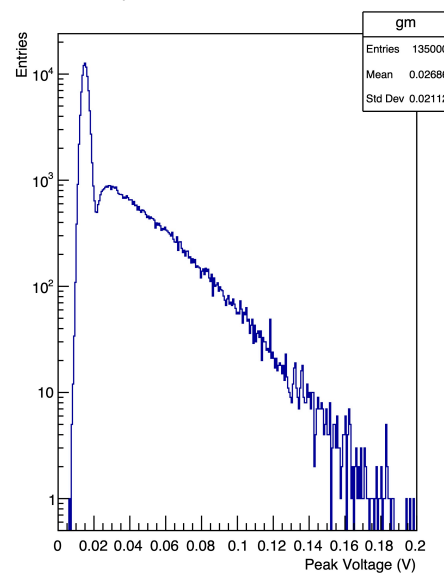
COMPASS GAS

A:350V D:500V

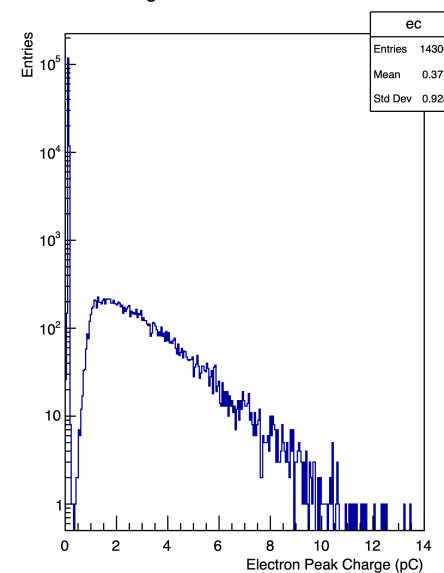
Charge Distribution: Root/run02



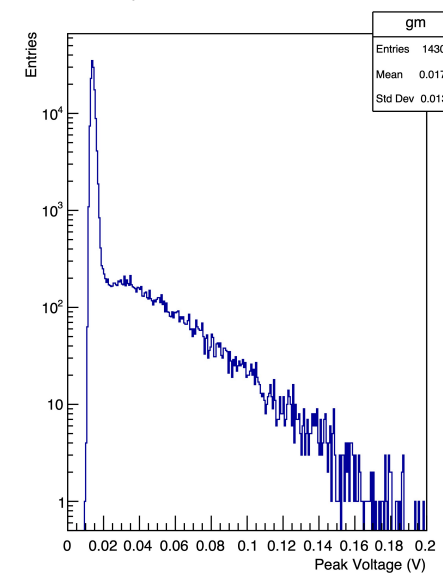
Amplitude Distribution: Root/run02



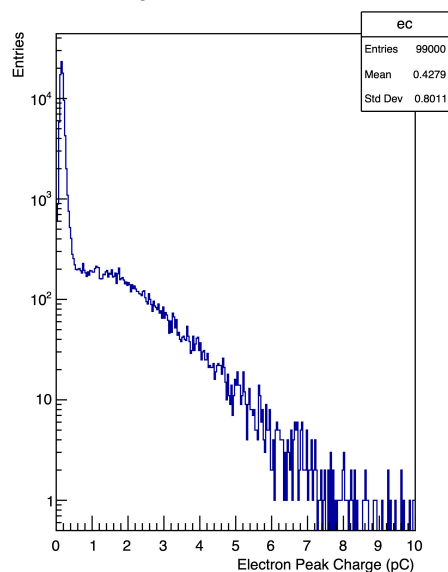
Charge Distribution: Root/run19



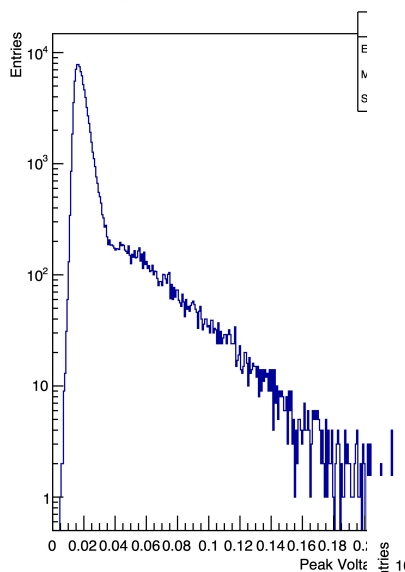
Amplitude Distribution: Root/run19



Charge Distribution: Root/run194



Amplitude Distribution: Root/run194



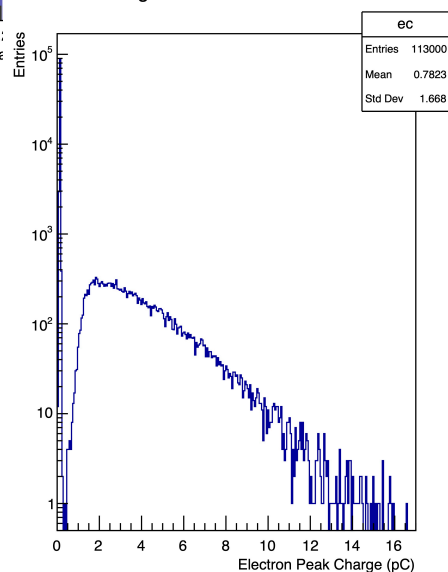
Ne 90%

A:350V D:425V

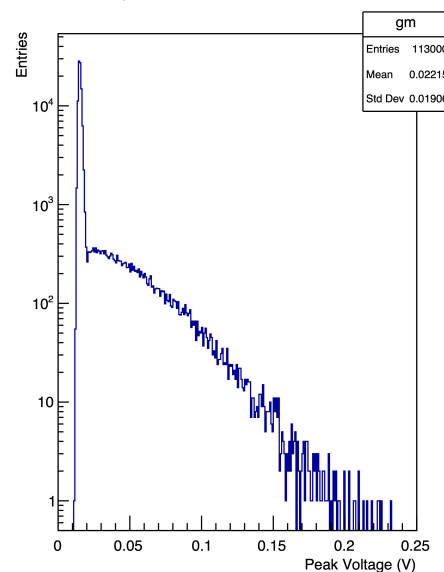
Ne 92.5%

A:350V D:390V

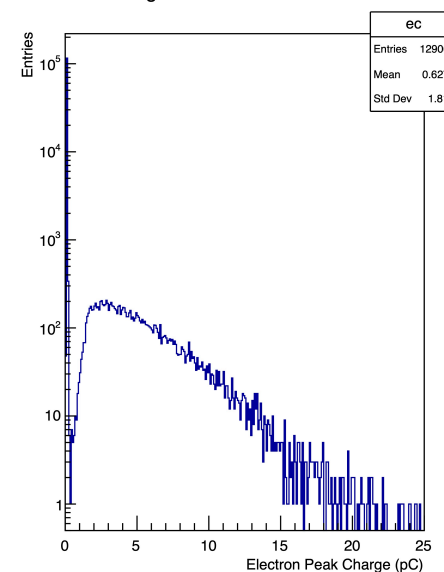
Charge Distribution: Root/run10



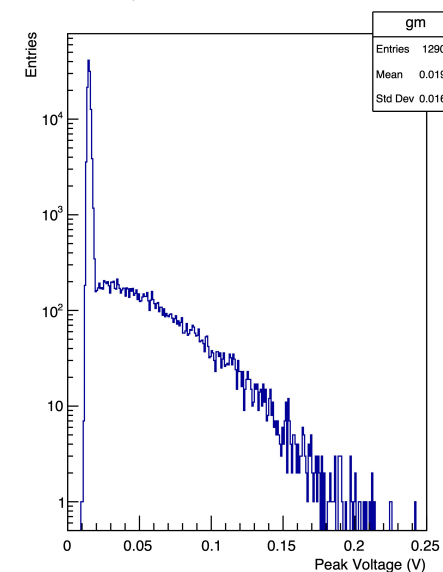
Amplitude Distribution: Root/run10



Charge Distribution: Root/run27



Amplitude Distribution: Root/run27



New Amplifier Tested

PICOSEC Amplifier „ATHR N3“



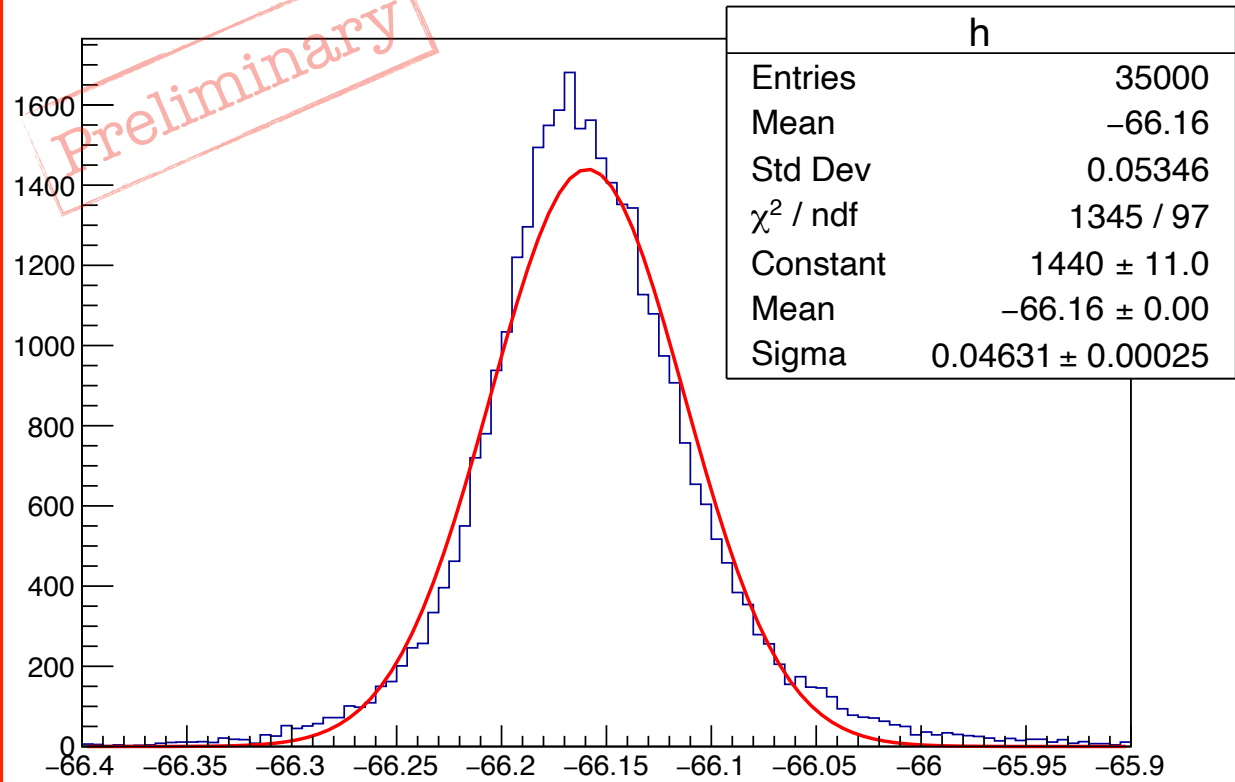
CIVIDEC „C2HV0177“



Anode: 275 V
Drift: 600 V
Drift gap: 194 μm
4 photoelectrons

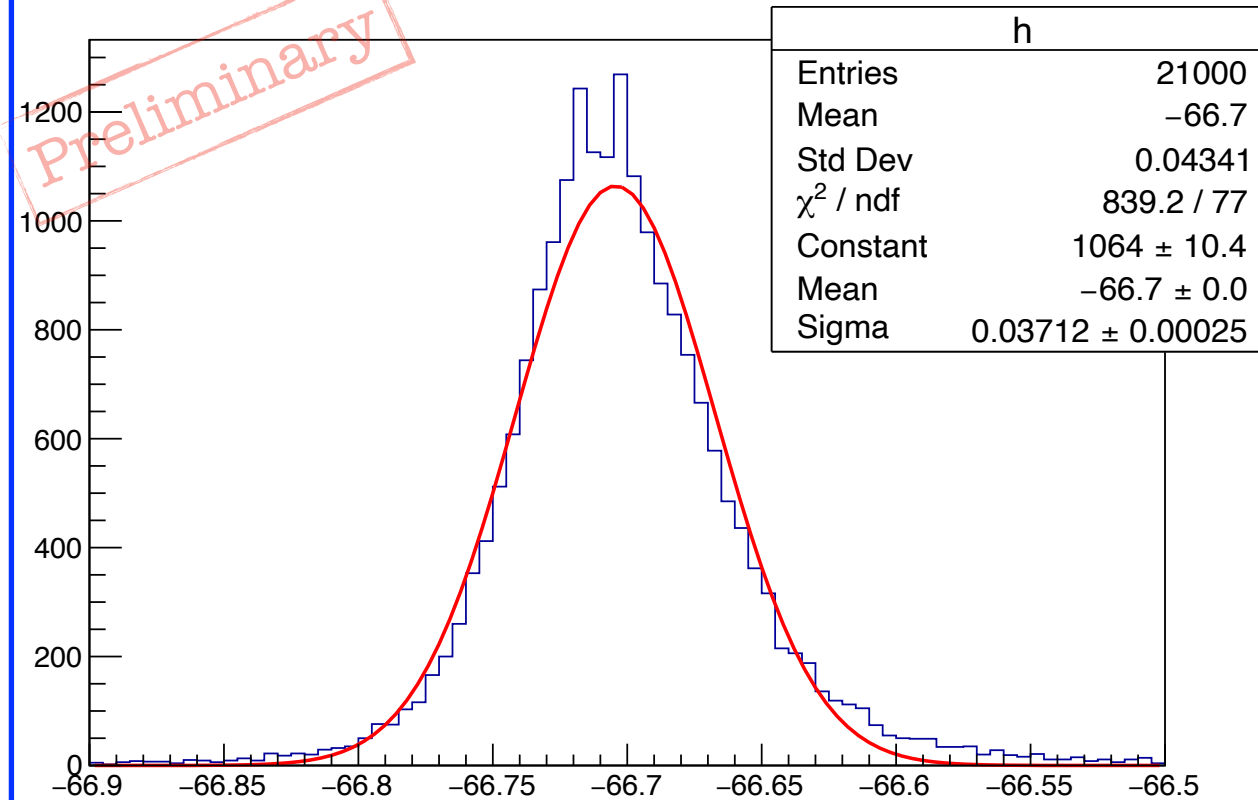
ATHR N3

MM1_naive_time-MCP1_naive_time



Cividec

MM1_naive_time-MCP1_naive_time



Comparison of selected waveforms

